

Low Noise Mix-Mode Integrated Circuits for Micro-sensor readout

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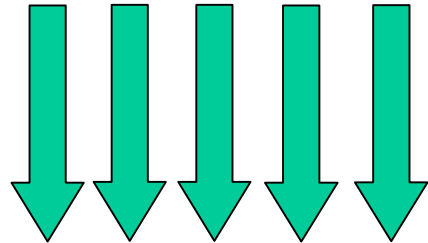
Outline

1. Introduction: multichannel low noise integrated circuit
2. Noise, crosstalk and matching
3. Digital imaging system for diffractometry applications
4. Multichannel neurobiology experiments
5. Conclusions



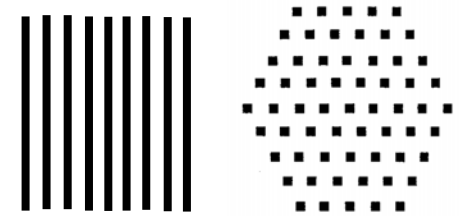
Multichannel low noise ASIC

SET OF SENSORS (silicon strip detector, neuronal cells of retina)



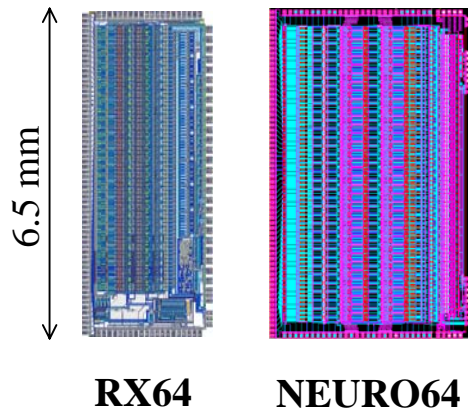
Input signals

- small amplitude ($Q_{in} = 1400 \text{ el}$, $V_{in} = 50 \mu\text{V}$)
- stochastic character (amplitude, time)



**Microsensors
50-100 μm**

MULTICHANNEL INTEGRATED CIRCUITS (analogue & digital blocks)



RX64

NEURO64

**LIMITS:
power & area**

**LOW LEVEL
OF NOISE**

**UNIFORMITY OF
PARAMETERS**

**CROSSTALK
digital \leftrightarrow analogue**



Noise in MOS transistors

1. Thermal noise of channel

saturation

linear

$$\overline{\frac{di_{th}^2}{df}} = \frac{8}{3} kT g_m$$

$$\overline{\frac{di_{th}^2}{df}} = 4kT g_{ds}$$

Simulations (HSPICE)

$$\text{NLEV}=3 \quad \overline{\frac{di_{th}^2}{df}} = \frac{8kT}{3} \mu C_{ox} \frac{W}{L} (V_{GS} - V_T) \frac{1+a+a^2}{1+a} GDSNIO$$

$$\text{BSIM3v3 (NIMOD=2)} \quad \overline{\frac{di_{th}^2}{df}} = \frac{4kT \mu_{eff}}{L_{eff}^2} |Q_{inv}|$$

Measurements – short channel effects (2-10x):

(velocity saturation, hot electrons)

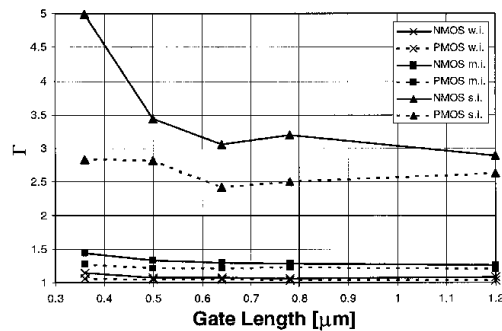
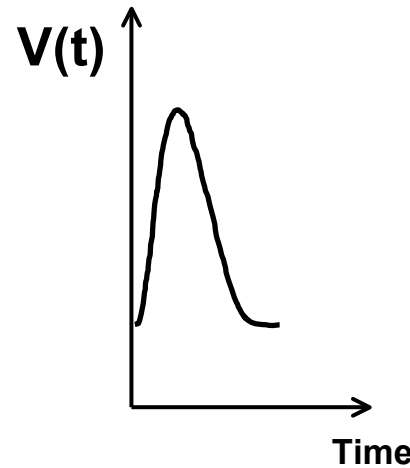
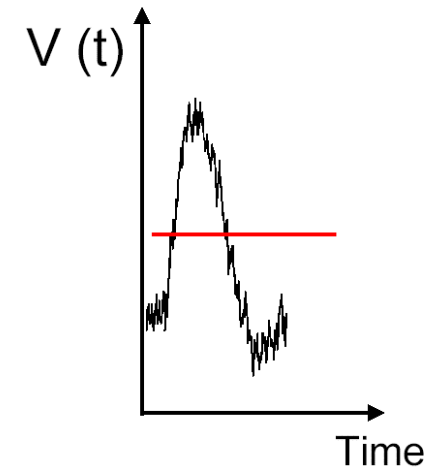


Fig. 4. White noise excess factor as a function of the device gate lengths for devices in weak (w.i.), moderate (m.i.) and strong (s.i.) inversion. The values are calculated as if the white noise measured came only from the channel thermal noise and the gate resistance thermal noise.



Signal



Signal+noise

2. Flicker noise

Simulations (HSPICE)

$$\text{NLEV}=2, 3 \quad \overline{\frac{di_{1/f}^2}{df}} = \frac{KF}{C_{ox}} \frac{g_m^2}{W_{eff} L_{eff}} \frac{1}{f^{AF}}$$

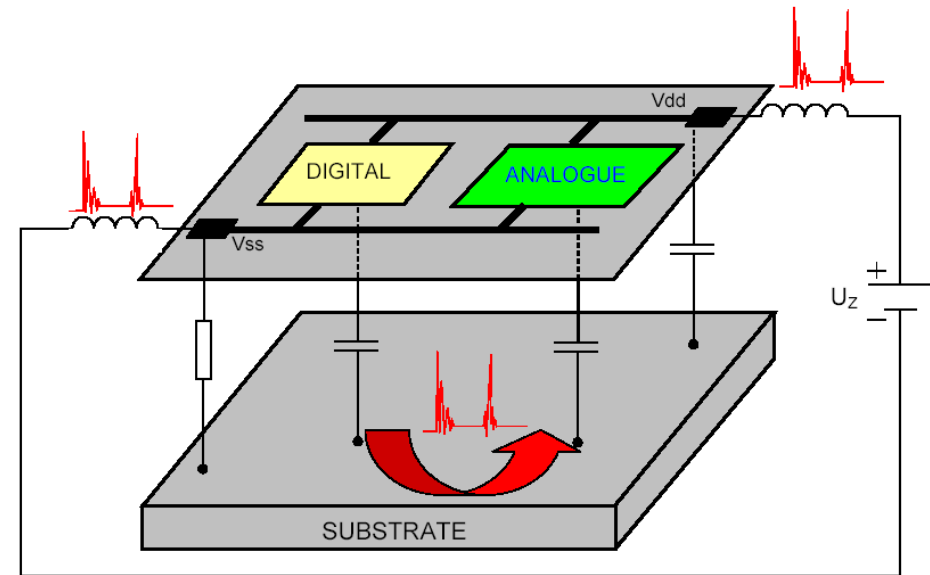
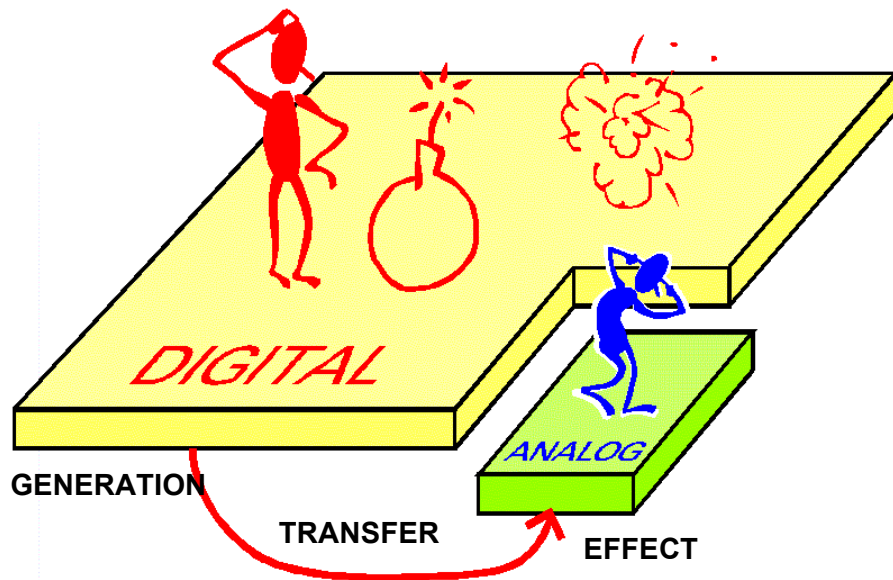
BSIM3v3 (NIMOD=2)

Measurements – short channel effects

(hot electrons, RST noise)



CROSSTALK



Transfer:

- common supply lines: parasitic inductance i resistance ($V_{ind}=LdI/dt$)
- common substrate: (substrate \Rightarrow epi, $V_T=f(V_{SB})$, g_{mb})

Effects for analogue blocks: switching noise, oscillation etc.

Minimisation:

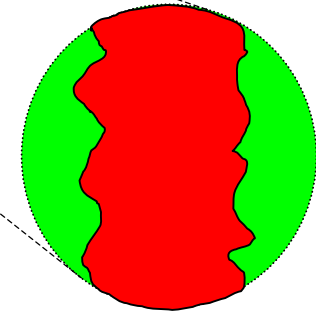
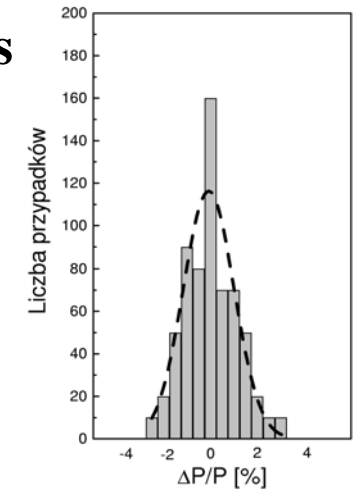
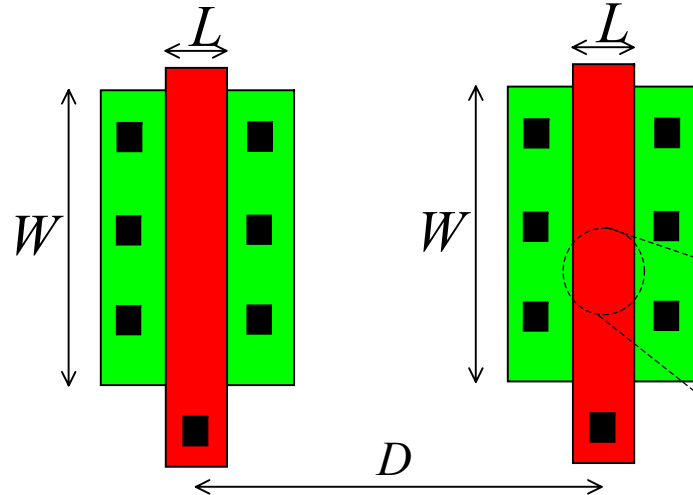
- reducing the noise generation,
- increasing the immunity of analogue part,
- isolation techniques.



RANDOM MATCHING

MATCHING - identically design devices have different parameters
 $\Delta P = P_1 - P_2$ ($\Delta P/P$)

$$\sigma^2(\Delta P) = \frac{A_P^2}{WL} + S_P^2 D^2$$



For MOS transistors: V_{T0} , β , γ

$$V_{T0} = \phi_{MS} + 2|\phi_F| - \frac{Q_{ox}}{C_{ox}} + \frac{\sqrt{4q\epsilon_s|\phi_F|N_B}}{C_{ox}}$$

$$\beta = \mu C_{ox} \frac{W}{L}$$

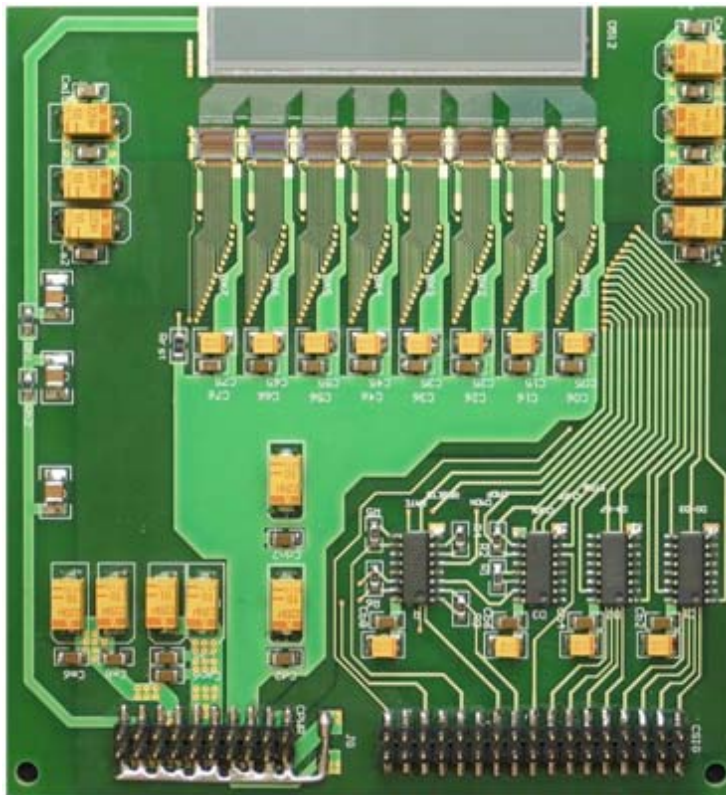
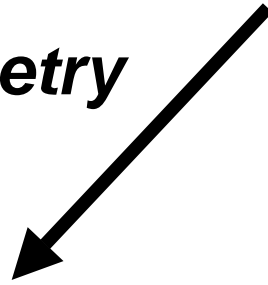
$$\gamma = \frac{\sqrt{2q\epsilon_s N_B}}{C_{ox}}$$

CMOS 0.7 μ m - $\sigma(V_{T0})$	NMOS	PMOS
W/L=2 μ m/0.7 μ m	9.72 mV	19.43 mV
W/L=1500 μ m/1.5 μ m	0.31 mV	0.63 mV

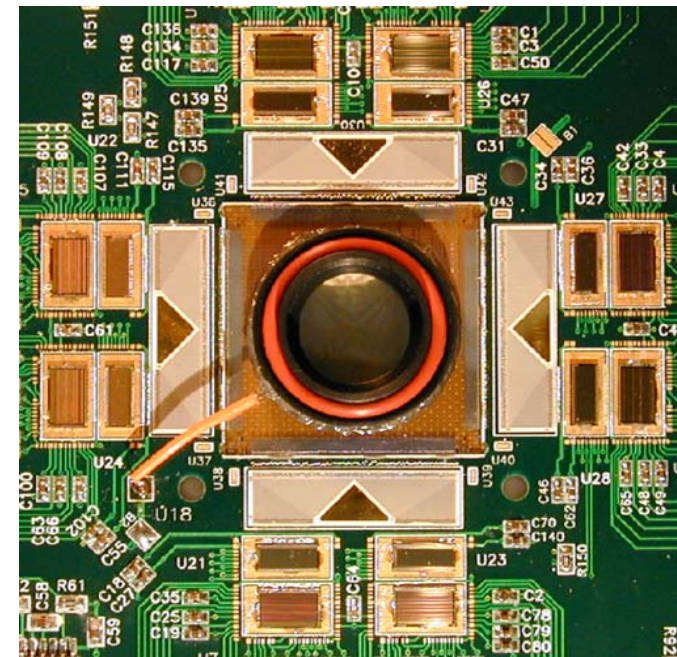
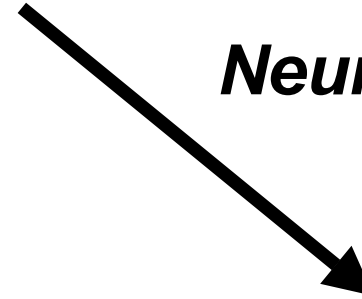


Two Examples of Low Noise Mix-Mode Integrated Circuits

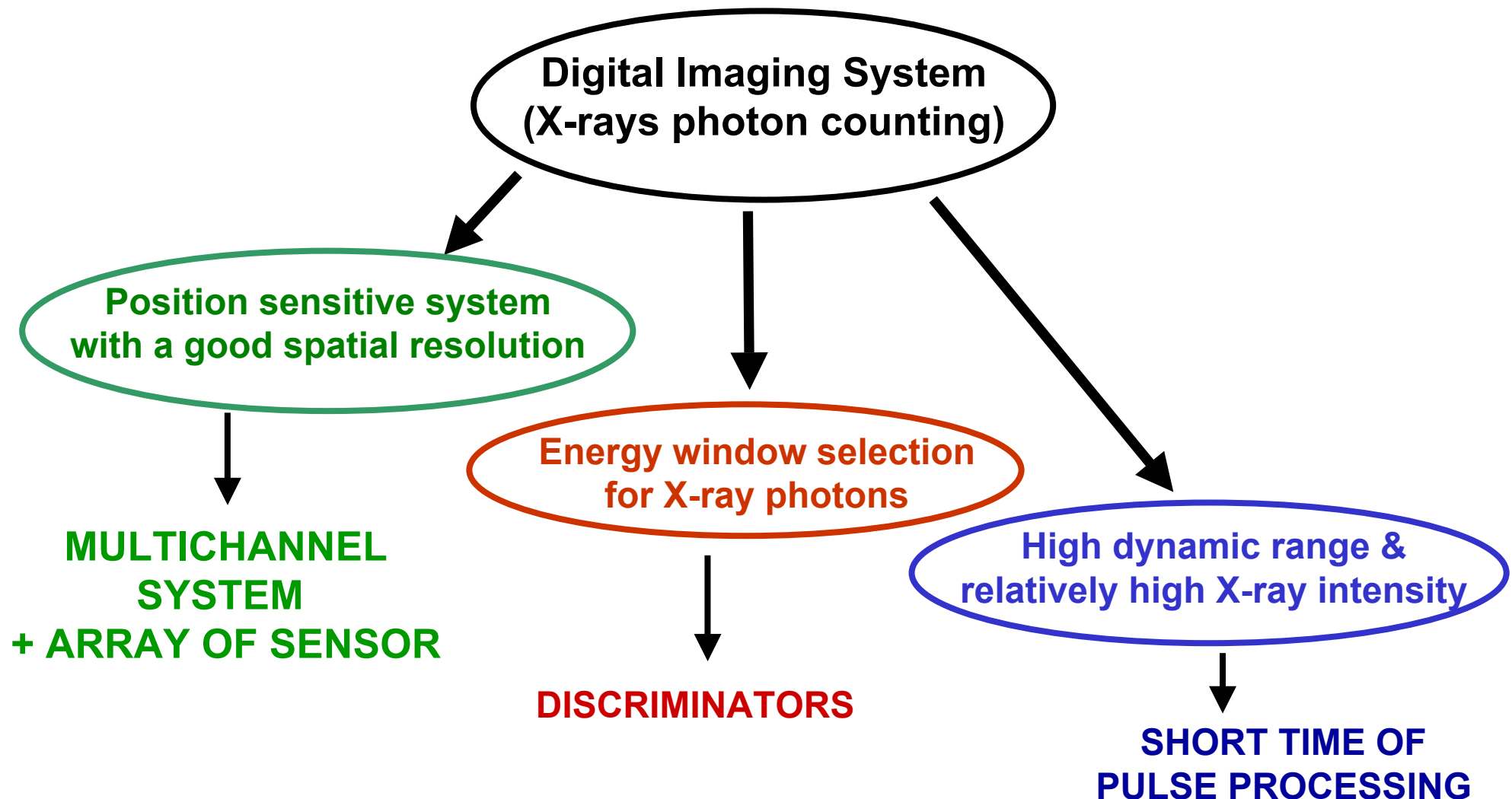
Diffractometry



Neurobiology



Digital X-ray Imaging System

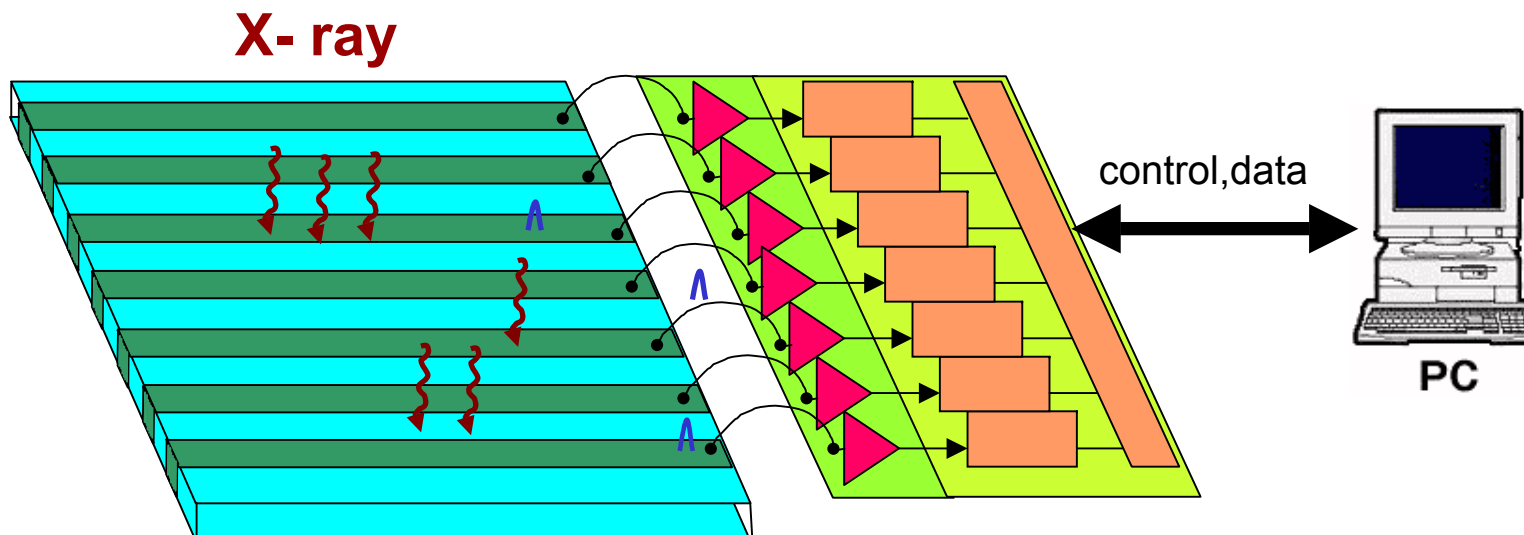


Applications:

- clinical diagnostic: dual energy mammography & angiography
- material science - diffractometry



Scheme of imaging system



Silicon strip detector



- good spatial resolution: tens of μm
- energy resolution: 3.67 eV/e-h
- single photon counting mode
 - good efficiency

Multichannel ASIC

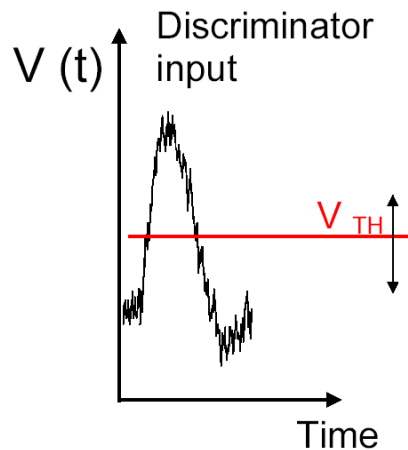
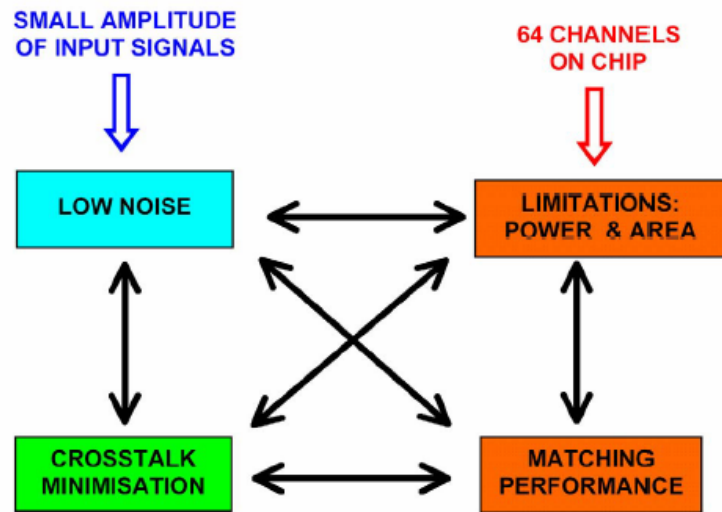
(analog processing + data storage)



- binary readout architecture to cope with **high X-ray intensity**
 - **selection** of pulses according their amplitude

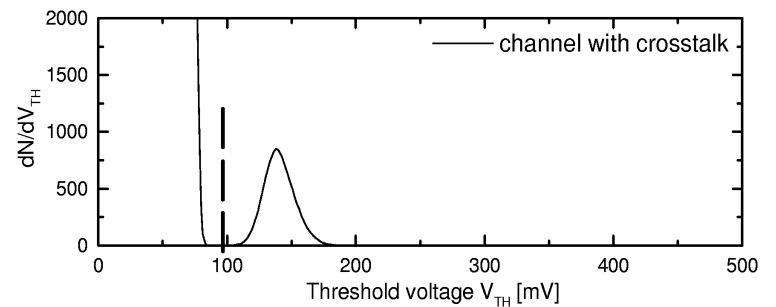
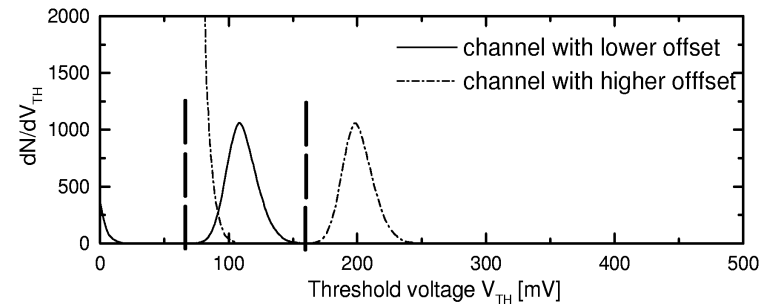
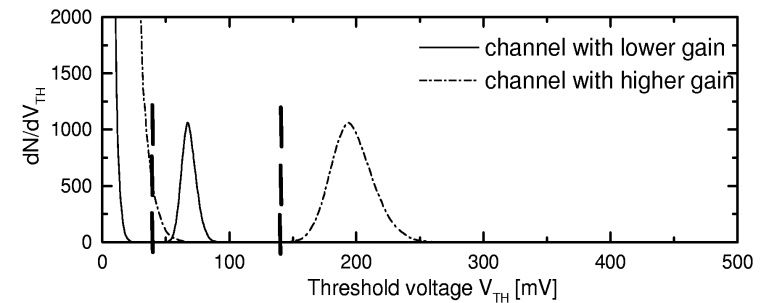
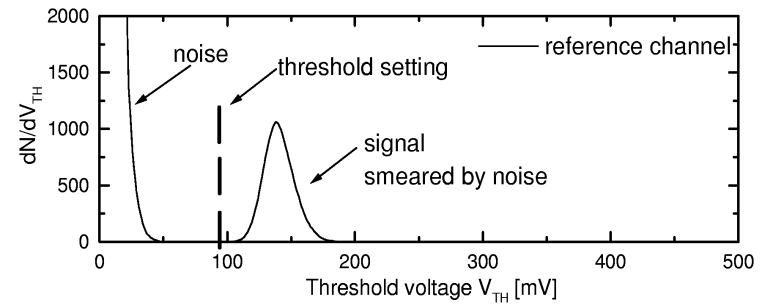


Problems with binary readout for X-ray applications



1) Counting pulses N

2) dN/dV_{TH}

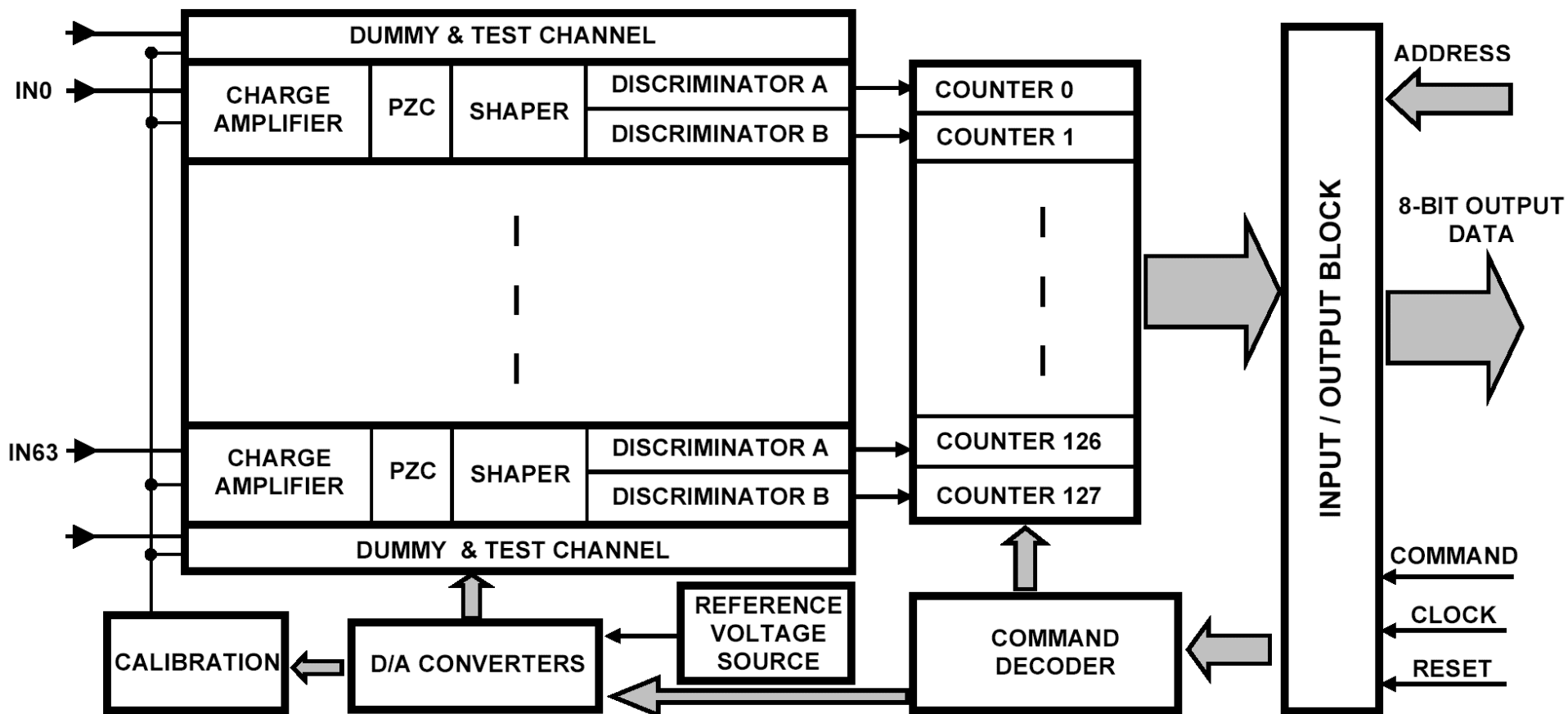


Pulse height spectrum



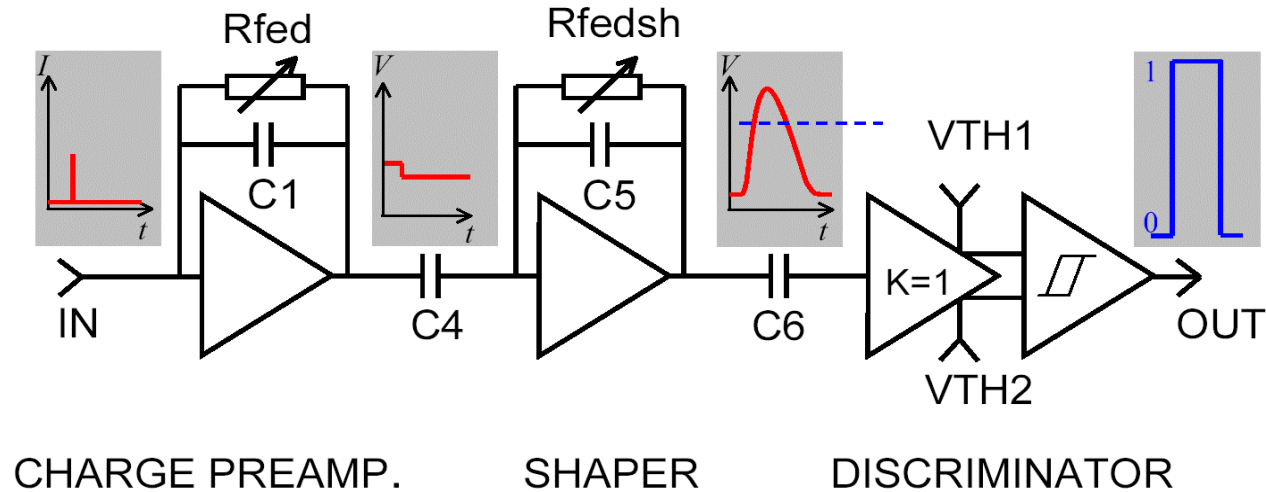
Multichannel ASIC architecture

DEDIX: Dual Energy Digital X-ray Imaging

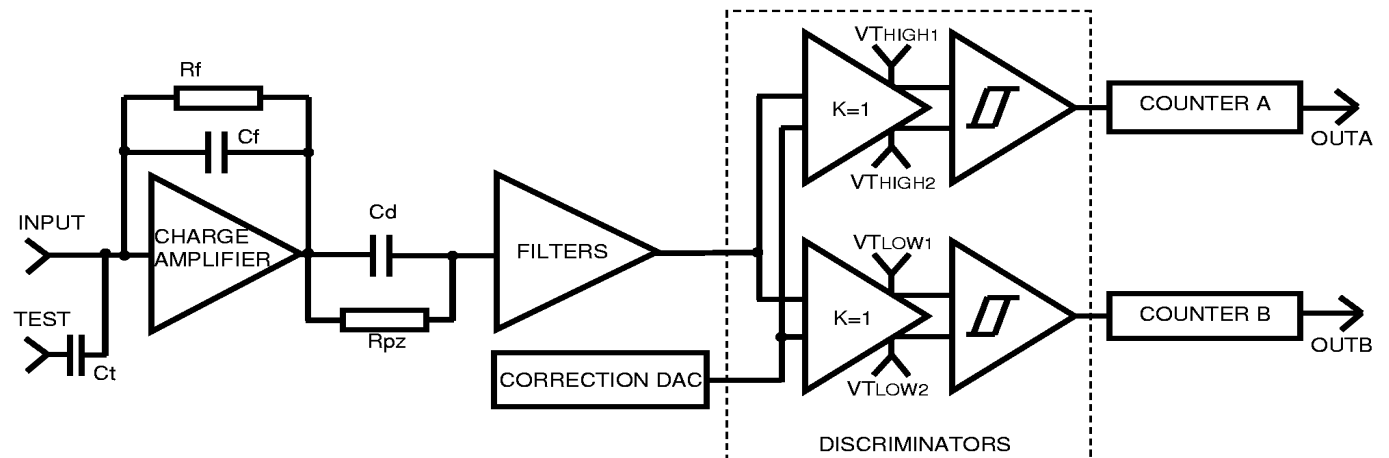


Single channel architecture (ASIC – 64 channels)

RX64:
 CMOS 0.8 μm
 $T_p = 800 \text{ ns}$

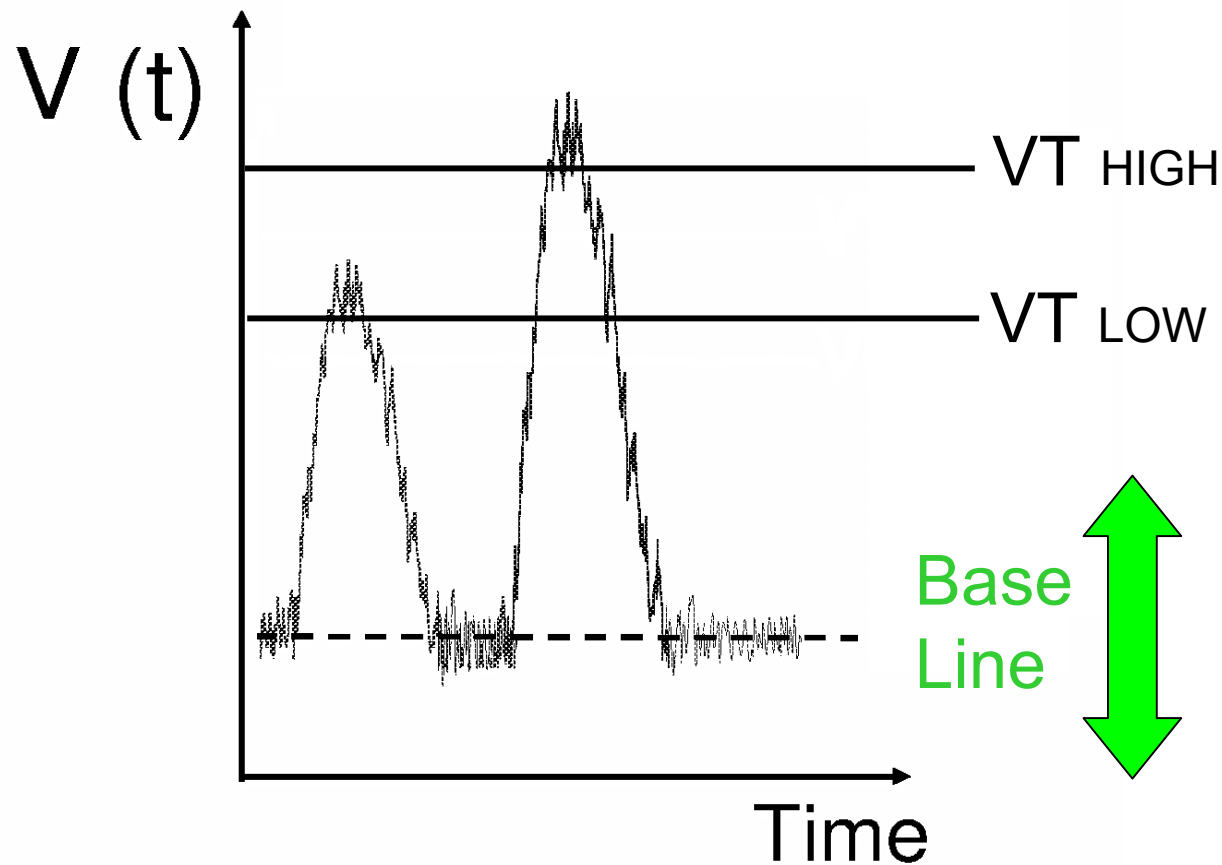


DEDIX :
 CMOS 0.35 μm
 $T_p = 160 \text{ ns}$

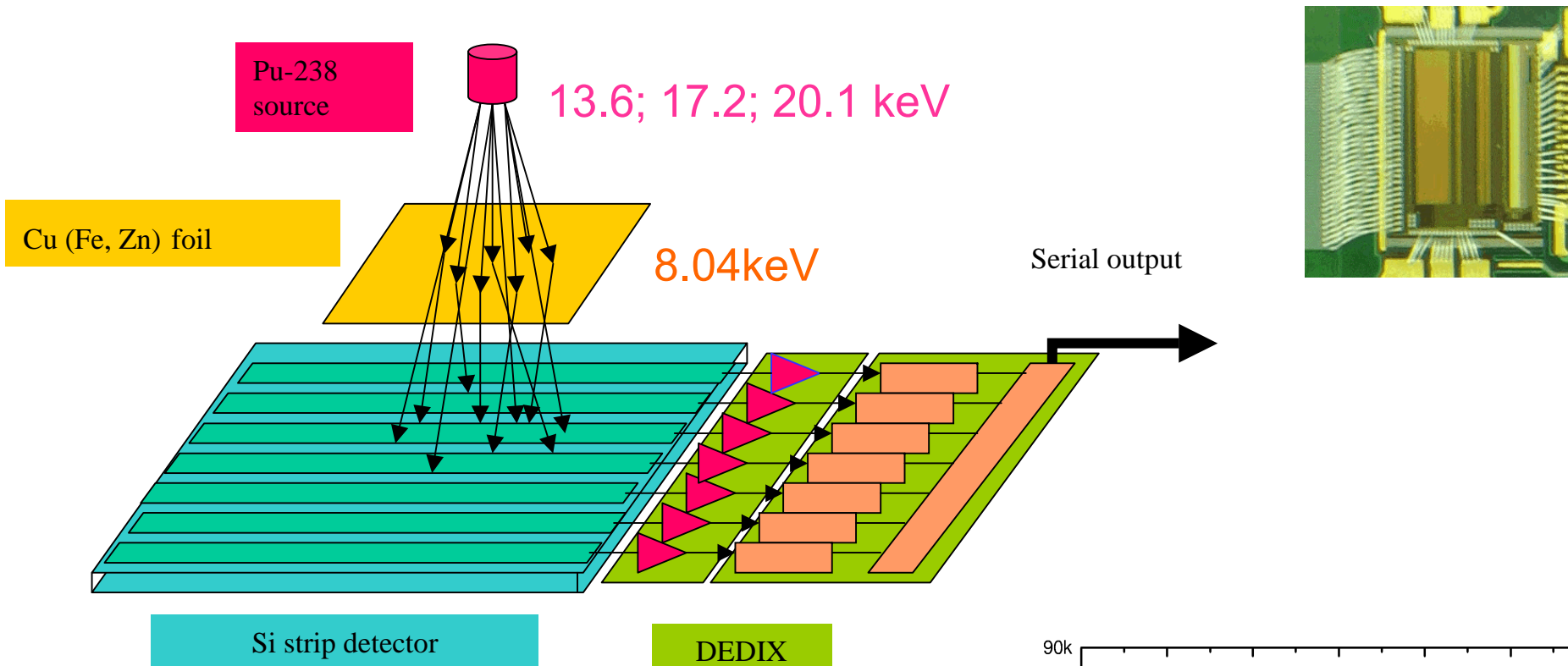


Why correction is necessary?

DC coupling between stages
– base line changes from channel to channel



Spectrum of X-ray source – measurement set-up

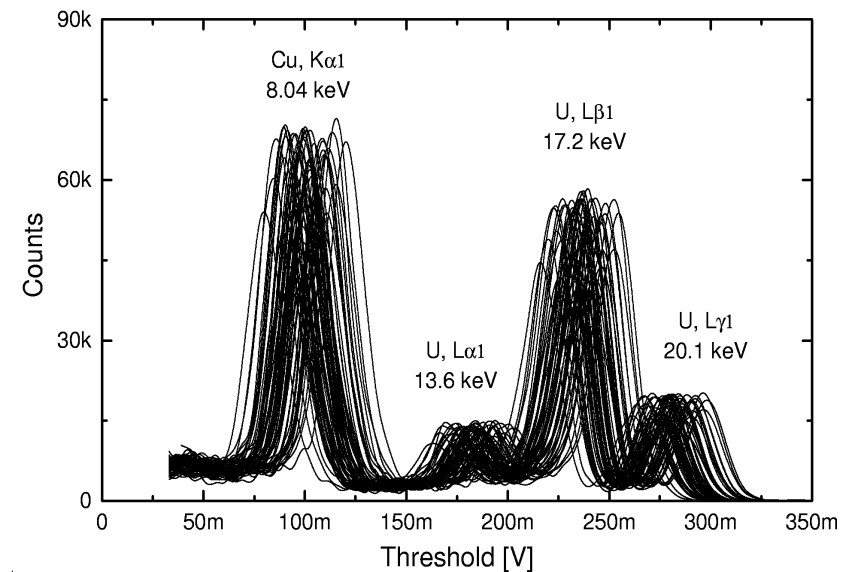


$$Q_1 = \frac{8.04 \text{ keV}}{3.67 \text{ eV}} = 2190 \text{ el}$$

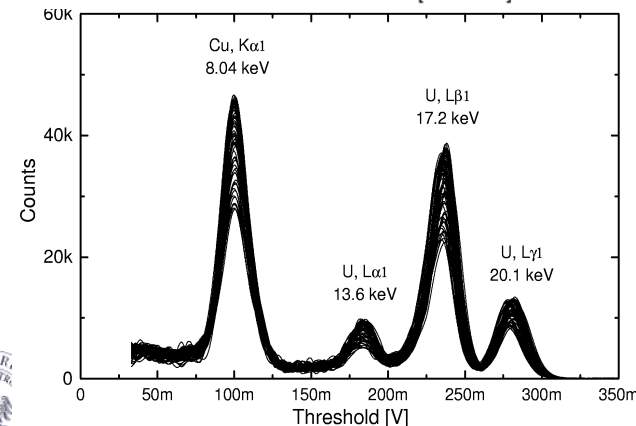
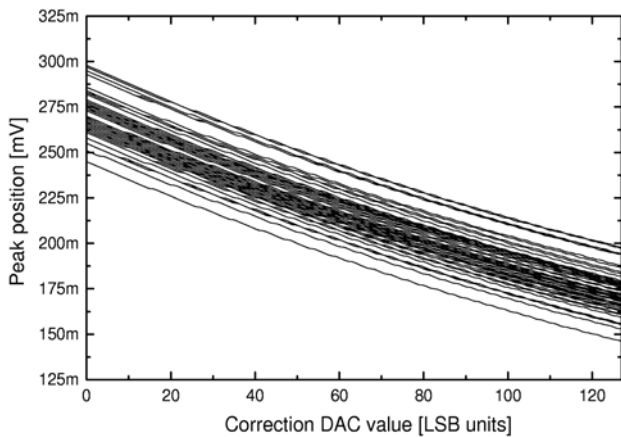
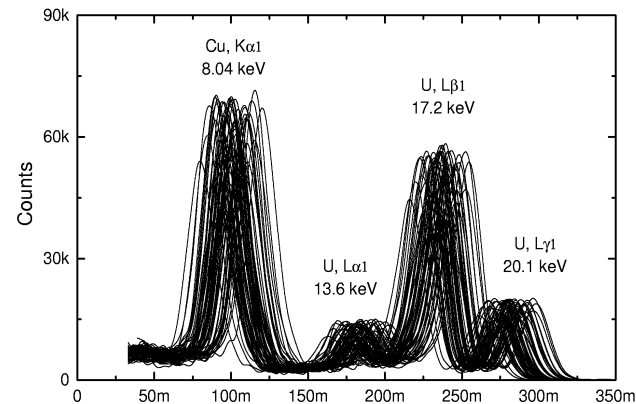
$$Q_2 = \frac{13.6 \text{ keV}}{3.67 \text{ eV}} = 3705 \text{ el}$$

$$Q_3 = \frac{17.2 \text{ keV}}{3.67 \text{ eV}} = 4686 \text{ el}$$

$$Q_4 = \frac{20.1 \text{ keV}}{3.67 \text{ eV}} = 5476 \text{ el}$$



Correction procedure



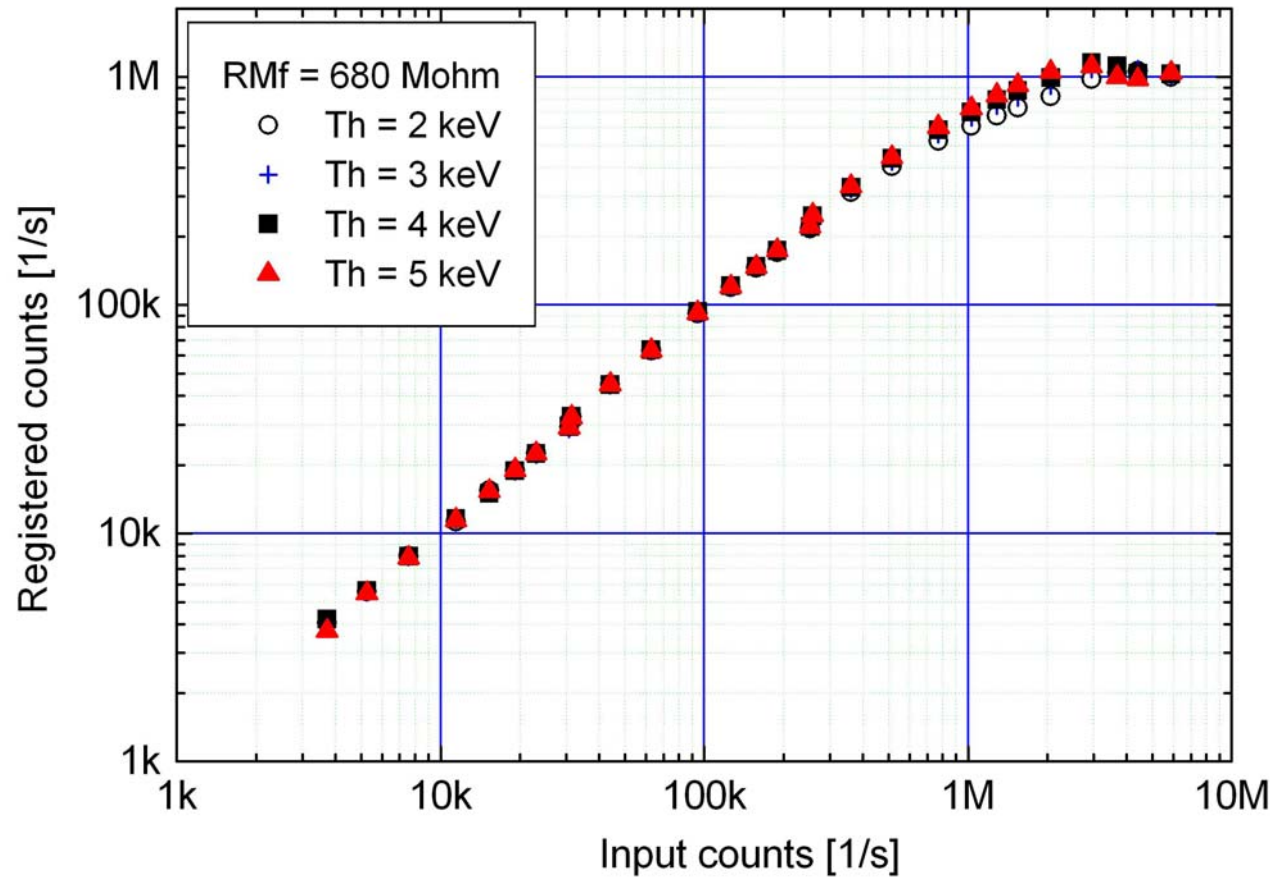
1. Measurement with external X-ray source gives us effective voltage spread (constant correction)

2. Measurements with internal generation circuit and different correction DAC's value gives us their nonlinear characterisation

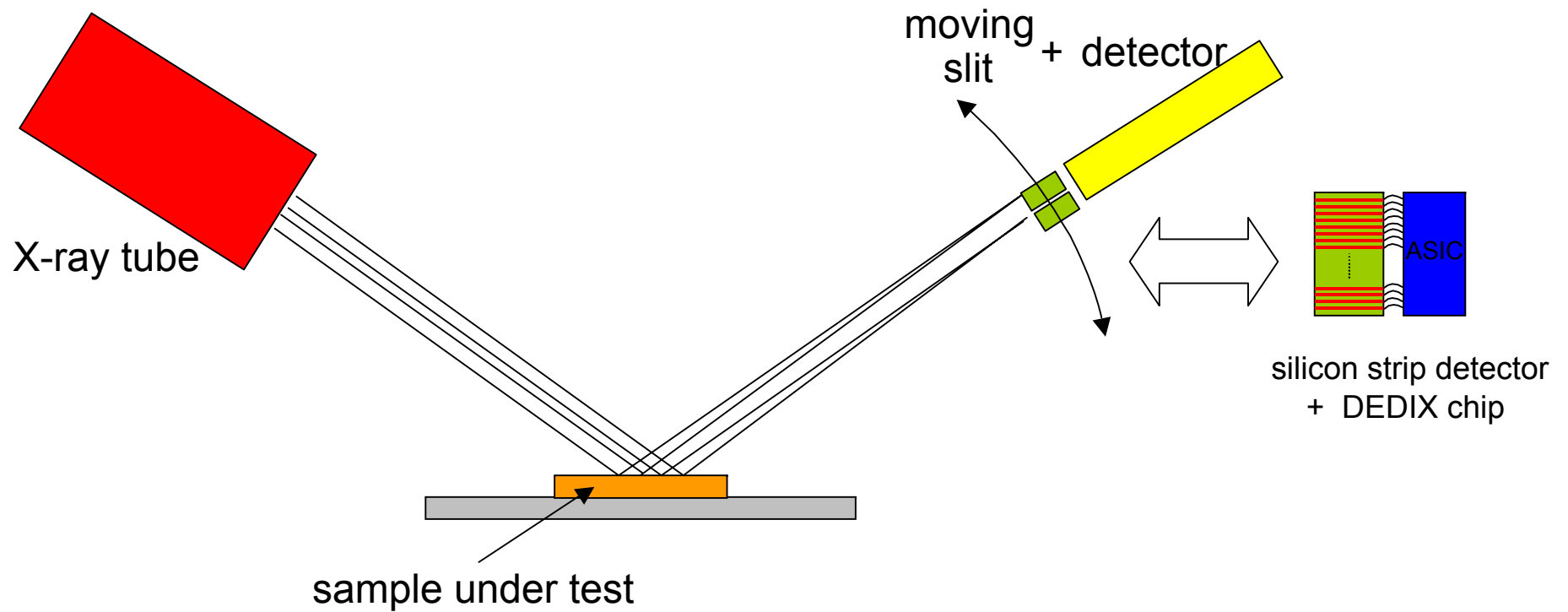
3. Calculation the value of correction DAC's – we know how much we want our threshold to be moved (1) and we know what DAC's value move the threshold to correct value (2)



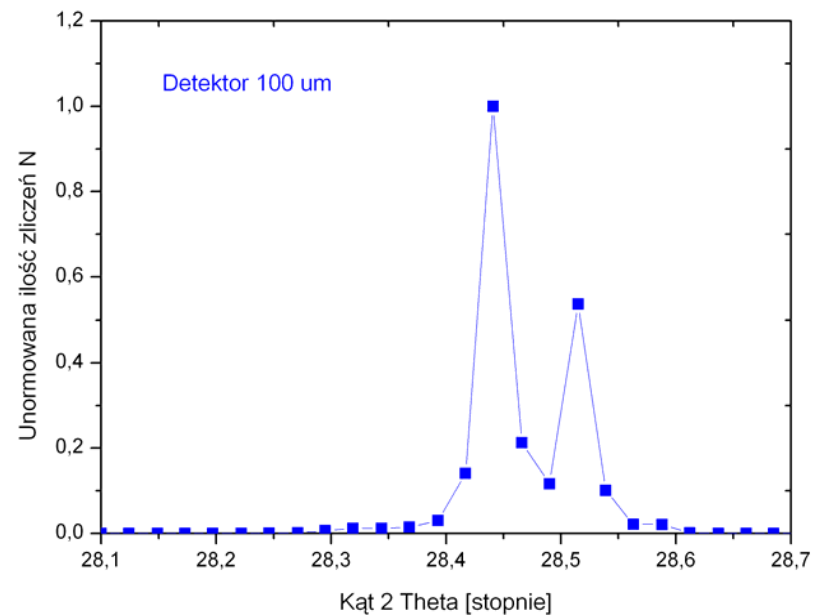
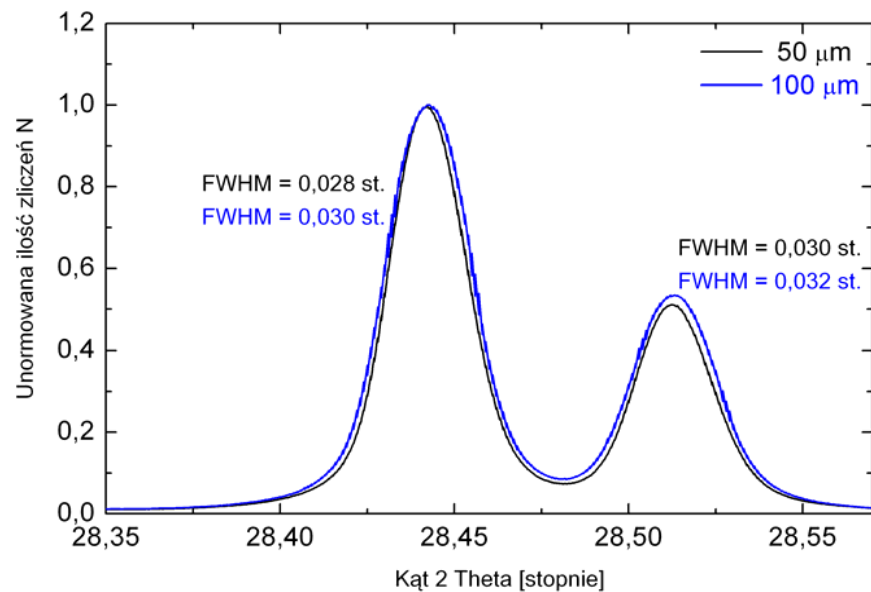
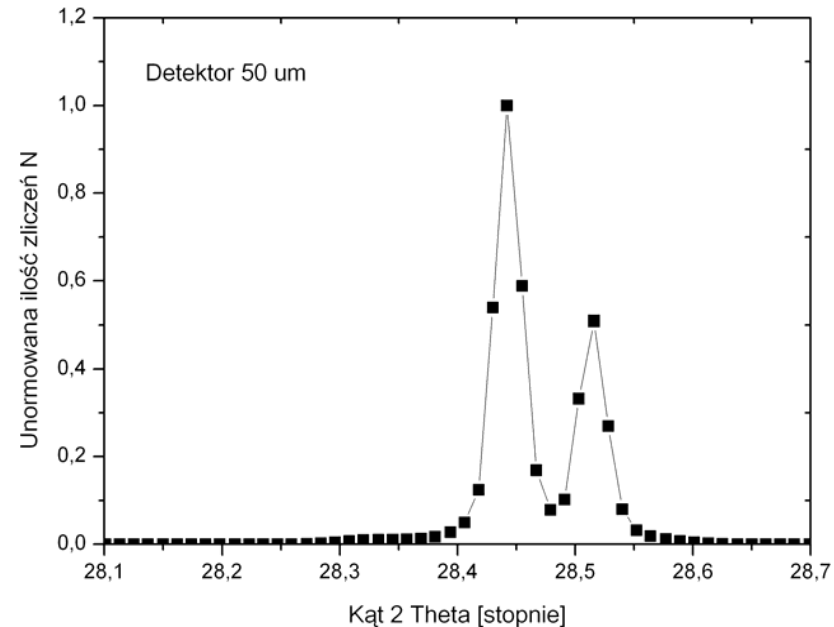
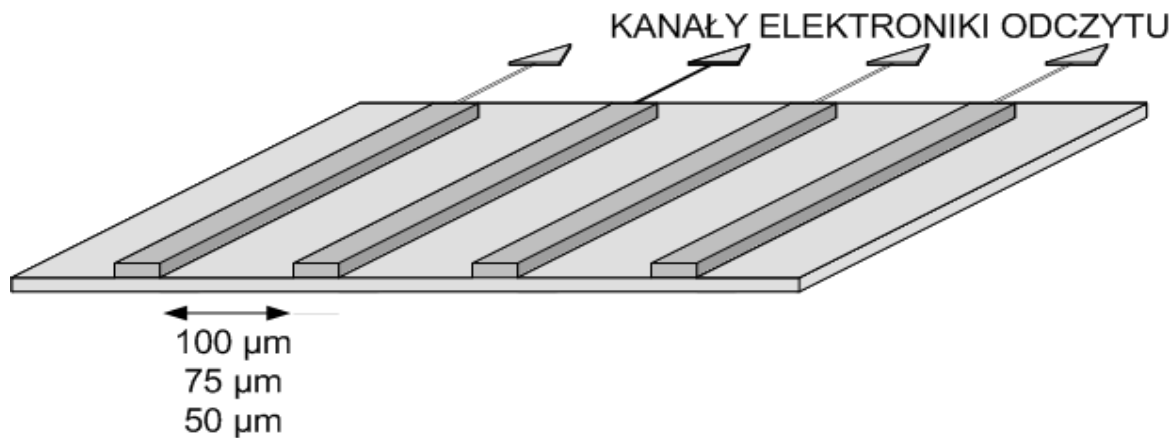
High count-rate measurement with X-ray tube



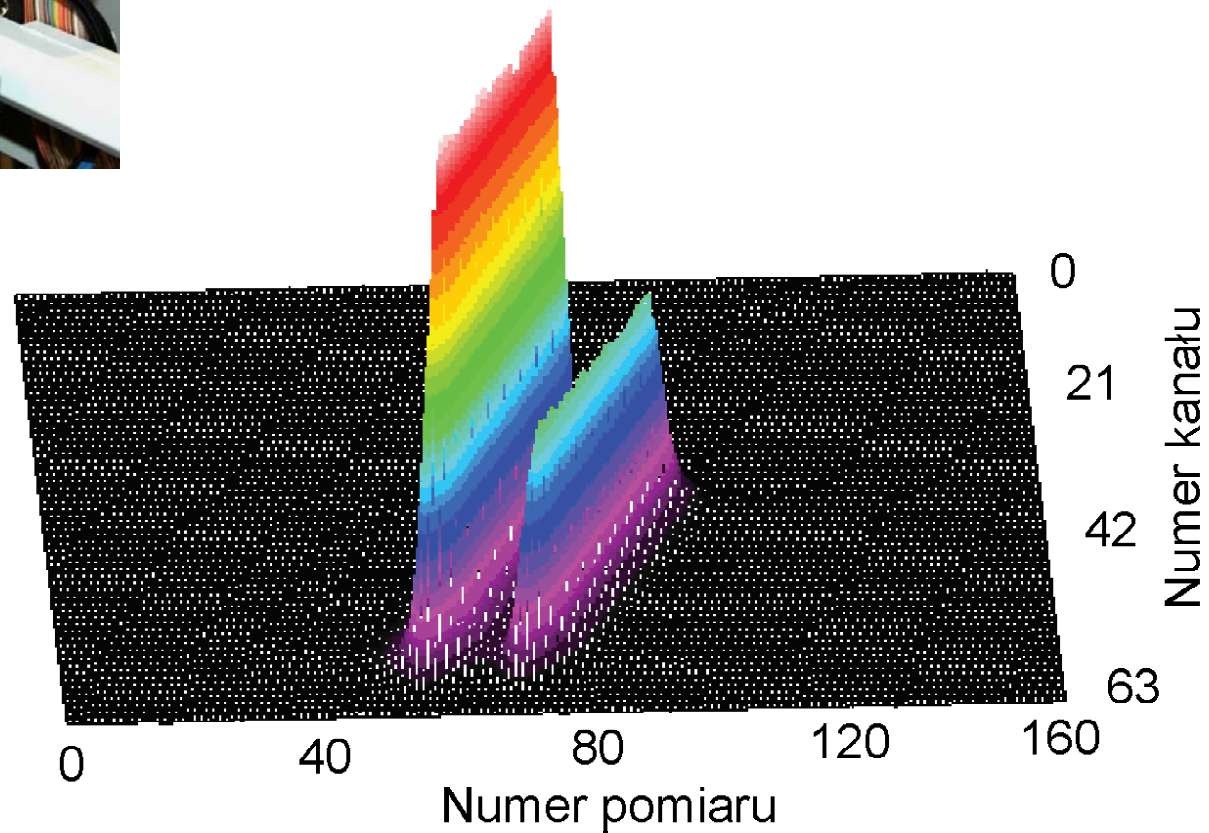
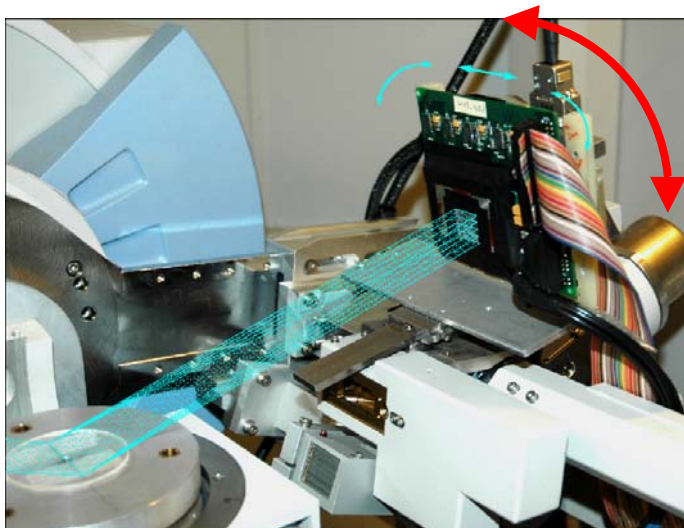
SSD in diffractometry



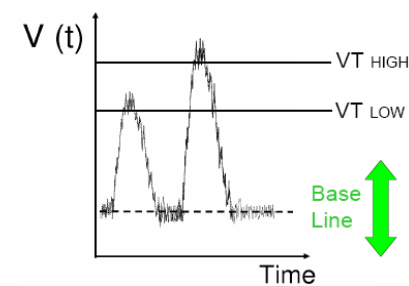
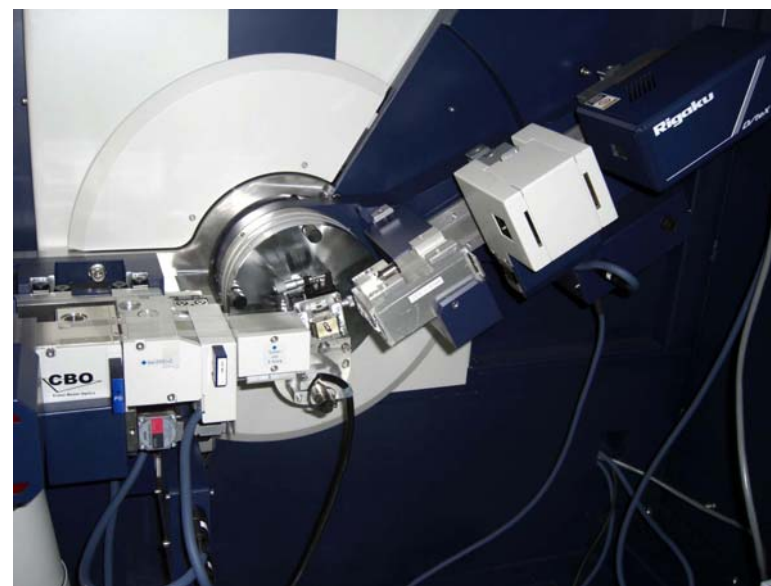
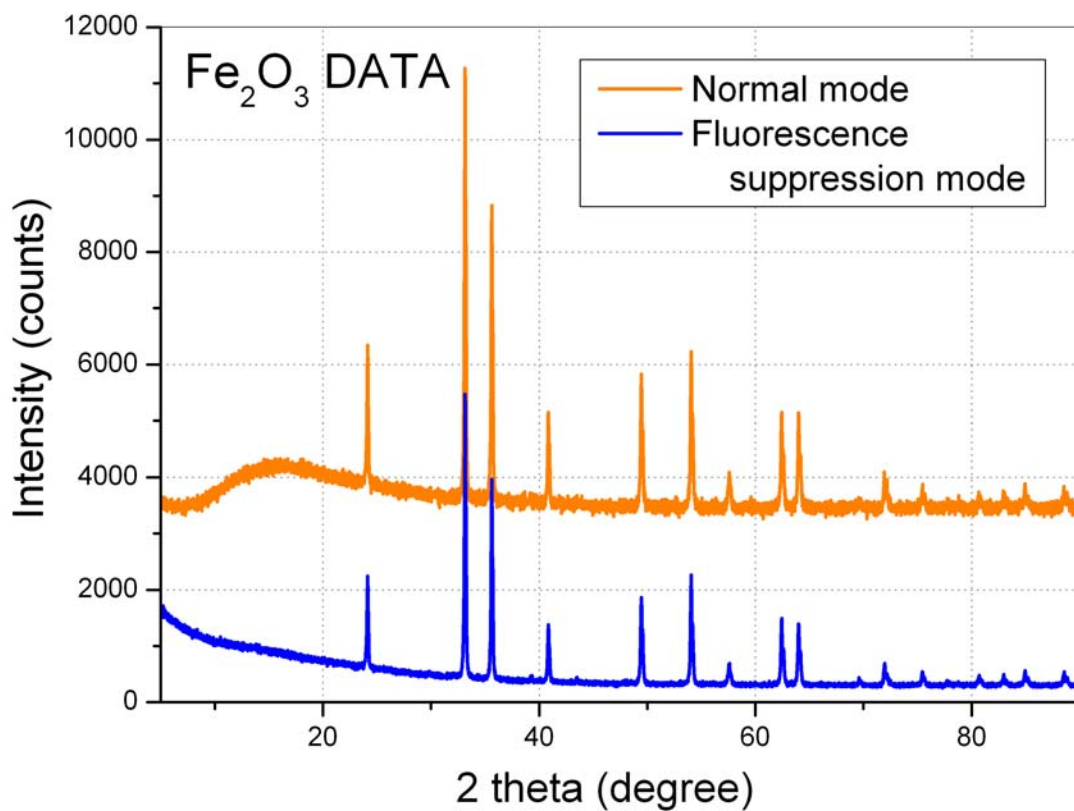
Detectors with different pitch



Continuous scan (prof. T. Stobiecki laboratory)

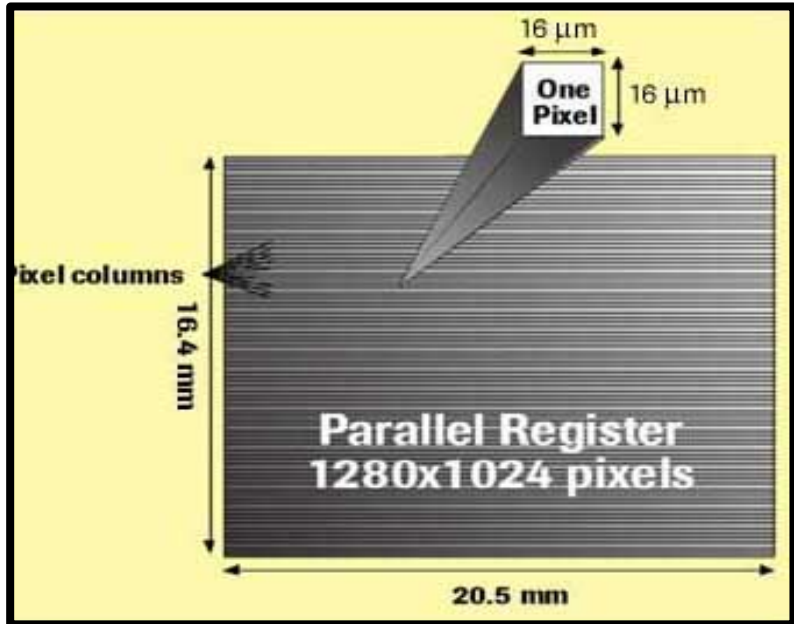
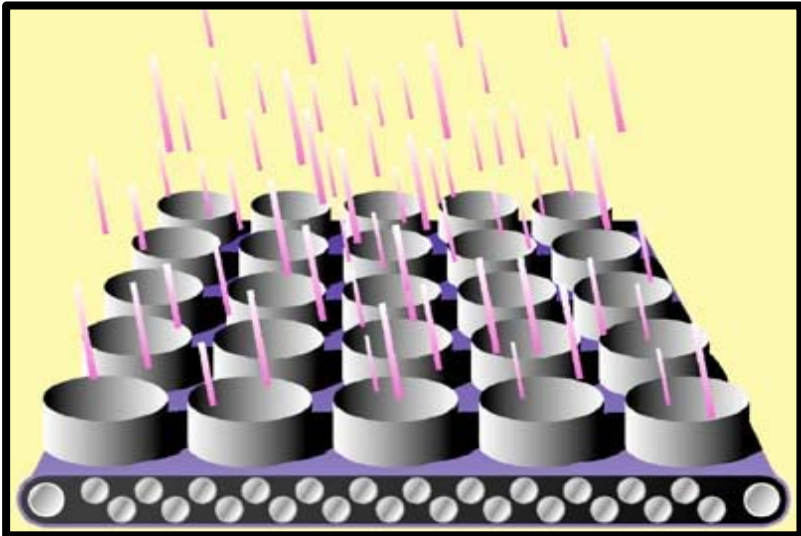
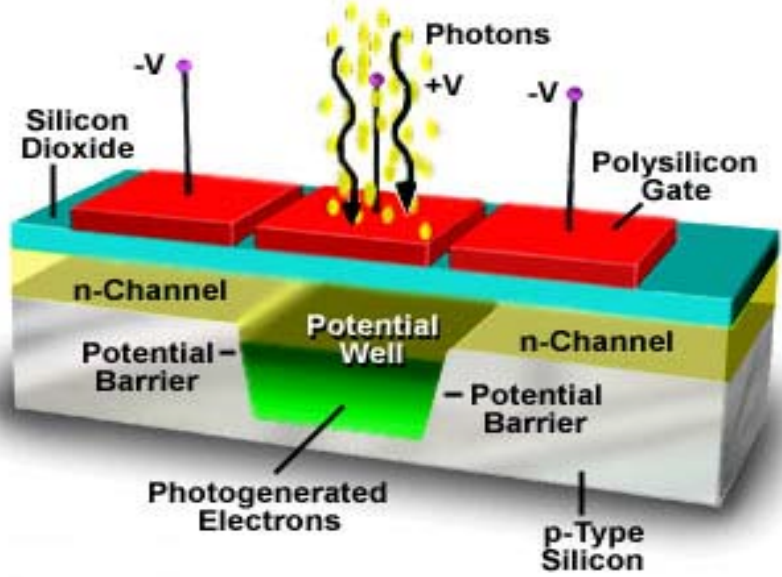


Fluorescence suppression - Rigaku, Japan

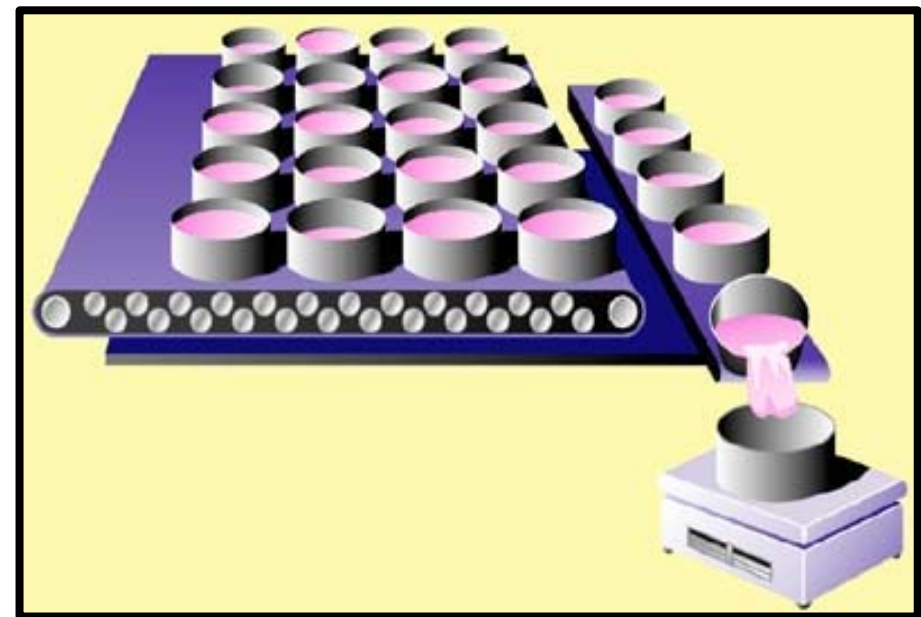
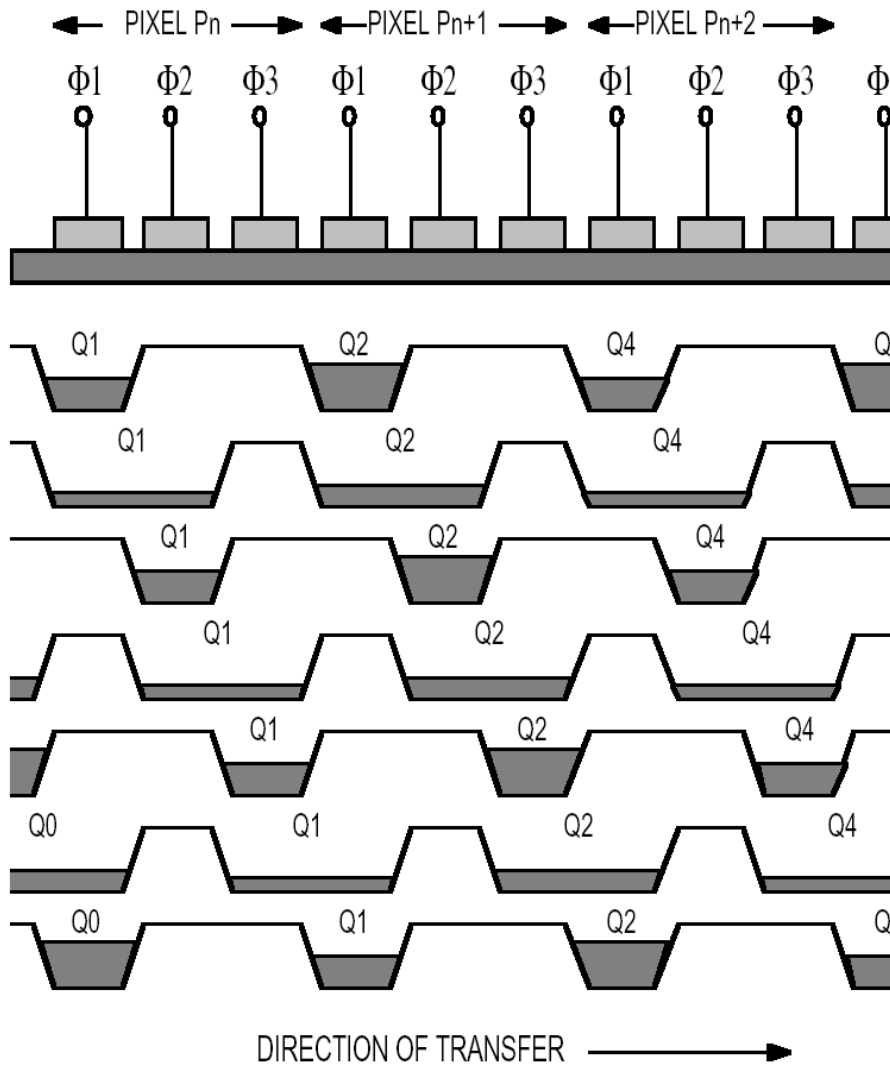


CCD detector

Metal Oxide Semiconductor (MOS) Capacitor

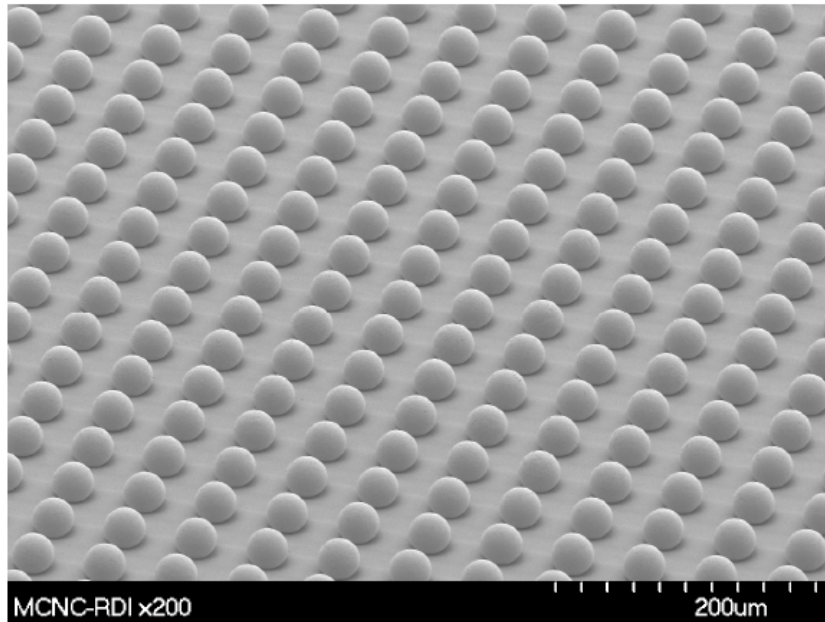


Readout of CCD

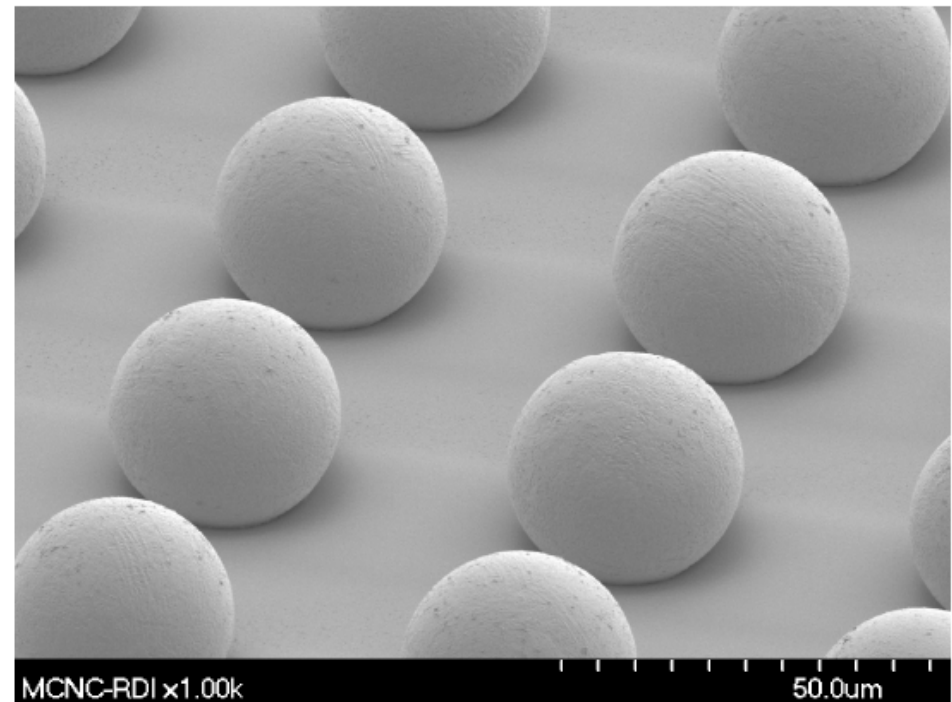


Bump Bonding

Bumps on the readout side

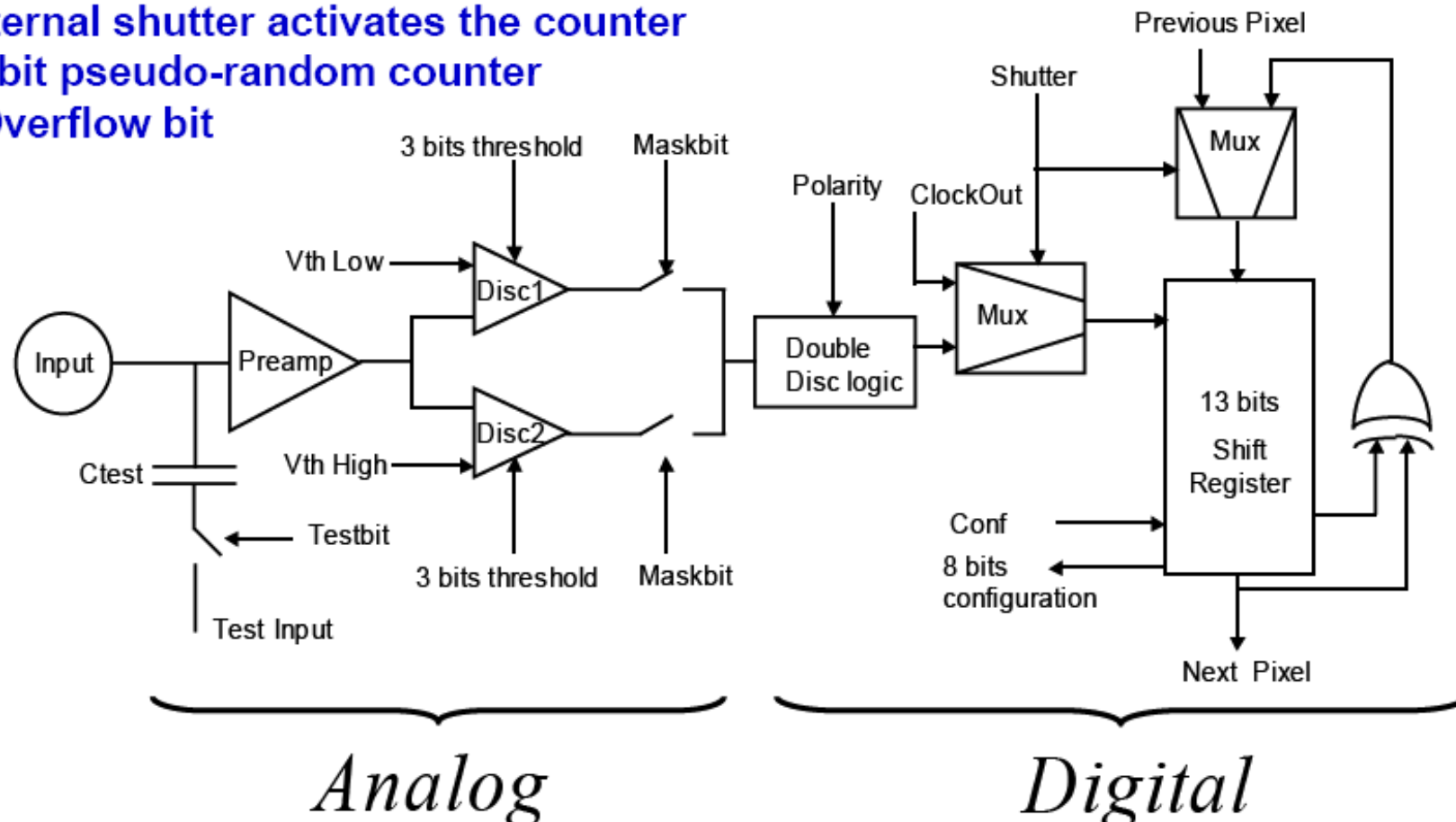


Bumps on the readout side – close up



Medipix -CERN

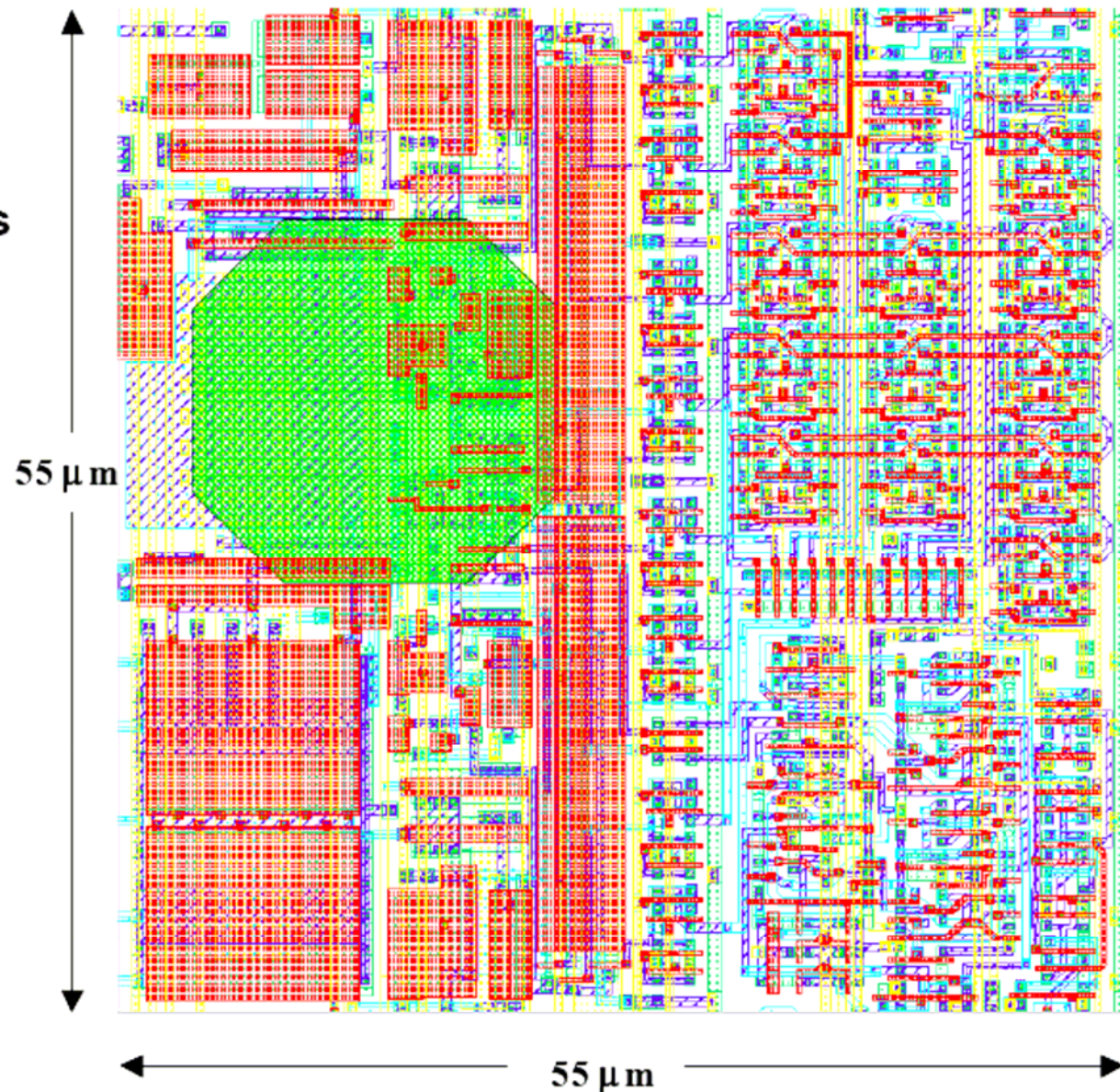
- Charge sensitive preamplifier with individual leakage current compensation
- 2 discriminators with globally adjustable thresholds
- 3-bit local fine tuning of the threshold per discriminator
- 1 test and 1 mask bit
- External shutter activates the counter
- 13-bit pseudo-random counter
- 1 Overflow bit



Medipix -CERN

503 transistors
per pixel

33M per Chip

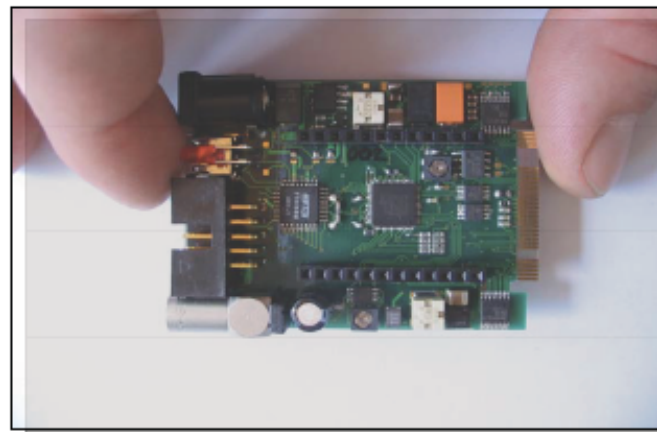


Medipix -CERN

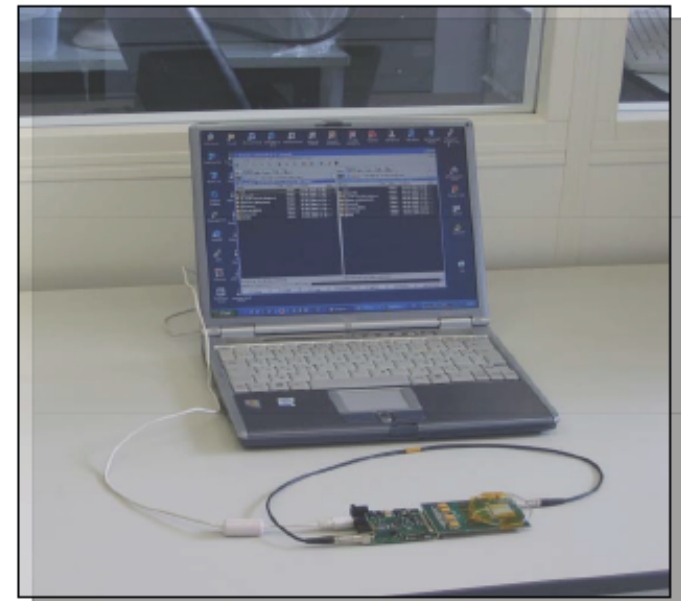
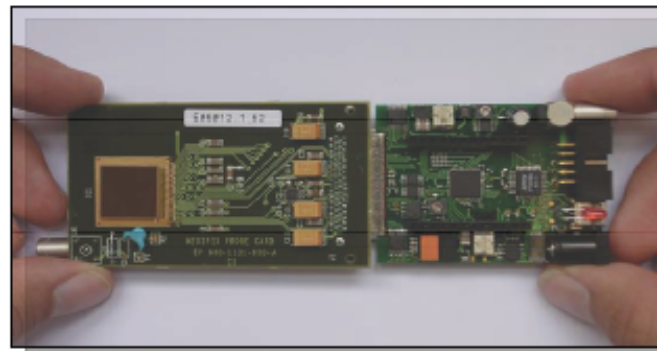
Medipix2 Si Assembly



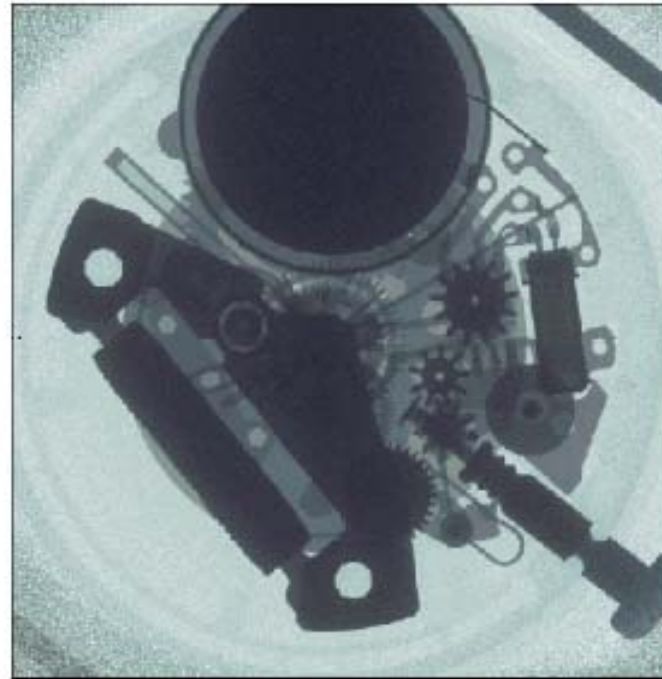
A new USB based Medipix2 Readout System



USB1 compatible
Developed by S. Pospisil et al.
CTU, Prague



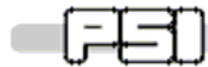
Medipix -CERN



**X-Ray movie at 5.5fps 512x512 pixels
Uses 4-chip Quad detector**



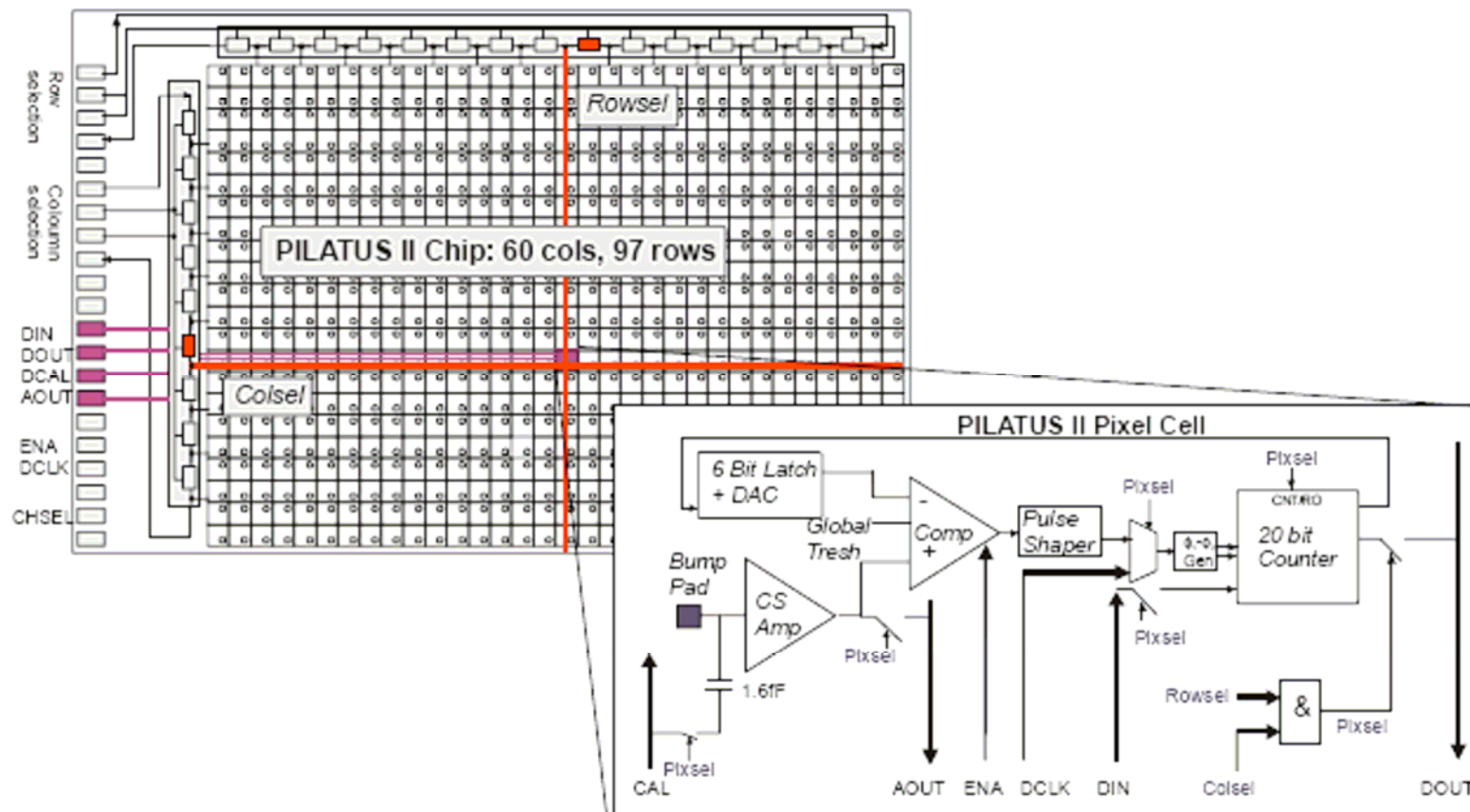
PILATUS - PSI



PAUL SCHERRER INSTITUT



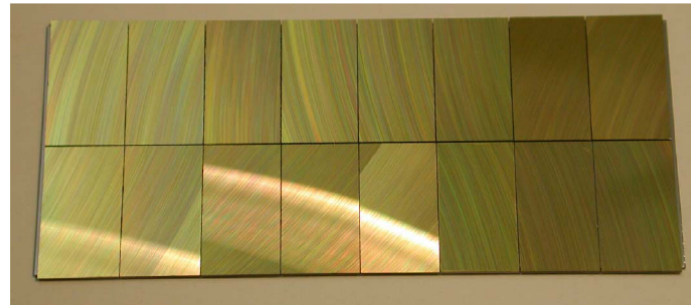
PILATUS chip architecture: Single photon counting electronics



PILATUS- PSI

Bump-Bonded Multi-Chip-Module (PILATUS I)

- Pixel size 0.217 x 0.217 mm²
- Chip has 44 x 78 pixels
- 16 chips bump-bonded to 1 Silicon Sensor
- Module has 366 x 157 pixels
- Active Area is 79.4 x 34.1 mm²



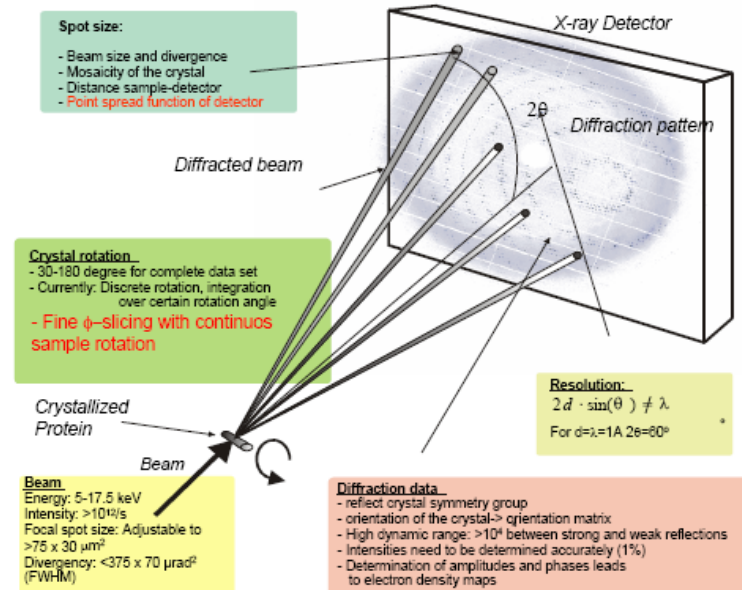
The PILATUS 1M Detector for Protein Crystallography

- Finished in Fall 2003
- First large area pixel detector for Protein Crystallography (Prototype)
- 6 banks a 3 modules, 1120 x 967 pixels
- Area: 21 x 24 cm²
- Readout time: 6.7ms
- 2 frames/ s
- Fine- ϕ slicing with continuous sample rotation
- Active area: 85%
- Moderate count rates (<10kHz/pixel)
- PX Data processing difficult due to limitations of PILATUS I chip
- Extremely important for further development of pixel detectors for PX



Brönnimann et al., *J. Synchrotron Rad.*, 13, 2005,120-130
The Pilatus 1M Detector.

Pixel Detectors for Protein Crystallography



Low Noise Mix-Mode Integrated Circuits for Neurobiology Applications

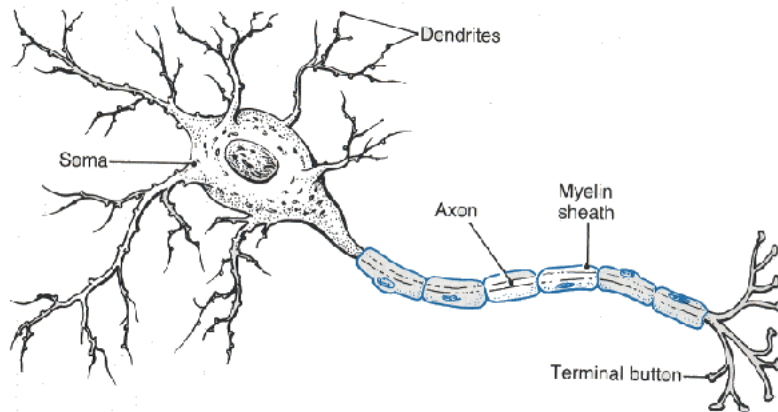


SP↓NSW↑TCH Workshop „Spin Momentum Transfer”, Kraków 2008

Katedra Metrologii

Akademia Górniczo-Hutnicza w Krakowie

History – single channel recording



First Recording of Action Potentials

JZ Young, 1937 - Anatomical Description of Squid Giant Axons

Hodgkin & Huxley, 1939 - record AP using Squid Giant Axon

No. 3651, OCT. 21, 1939

NATURE

p.711

was lowered through the cannula into the intact nerve beneath it. The micro-electrode consisted of a glass tube about $100\ \mu$ in diameter and 10-20 mm. in length; the end of the tube was filled with sea water, and electrical contact with this was made by a $20\ \mu$ silver wire which was coated with silver chloride at the tip. Fig. 1 is a photograph of an electrode

Legume Nodule
The extent of is governed prim
Quantitative in
drate and nitrog
ever, somewhat
subject, conduct
here reported up

The experime
standard manor
chemical analys
legumes were co
these legumes an
These tissues we
plants, washed,
Warburg respir
desired. The out
given below.

Variations in
nodules of differ
than between sea
selection of a spe
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to root tissues.

The inner tissu
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in different parts

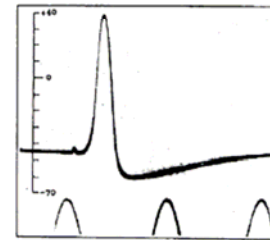
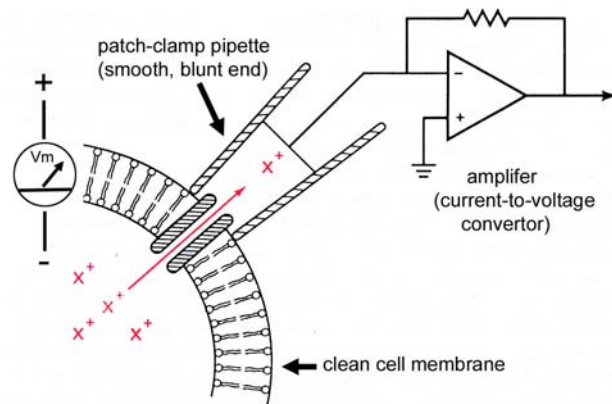
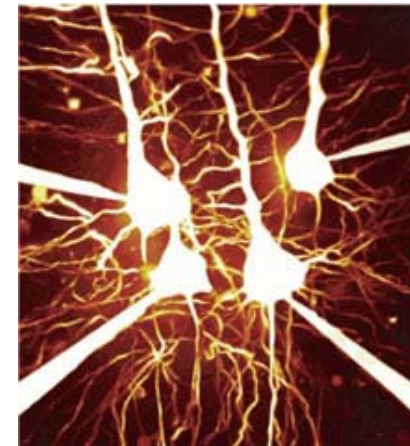


Fig. 2.

ACTION POTENTIAL RECORDED BETWEEN INSIDE AND OUTSIDE OF AXON. TIME MARKER, 500 CYCLES/SEC. THE VERTICAL SCALE INDICATES THE POTENTIAL OF THE INTERNAL ELECTRODE IN MILLIVOLTS, THE SEA WATER OUTSIDE BEING TAKEN AT ZERO POTENTIAL.

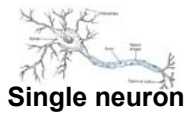
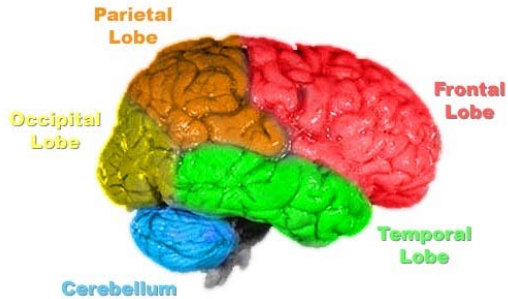


'Patch-clamp' technique :
Neher & Sakmann, 1976, (Nobel Prize 1991)



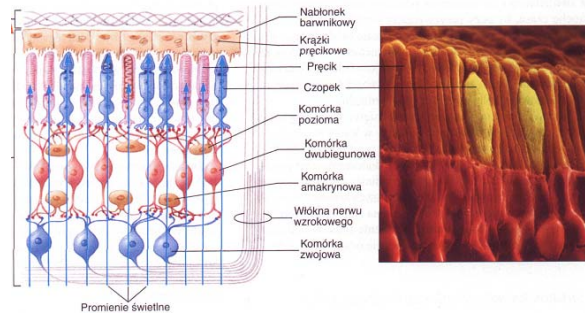
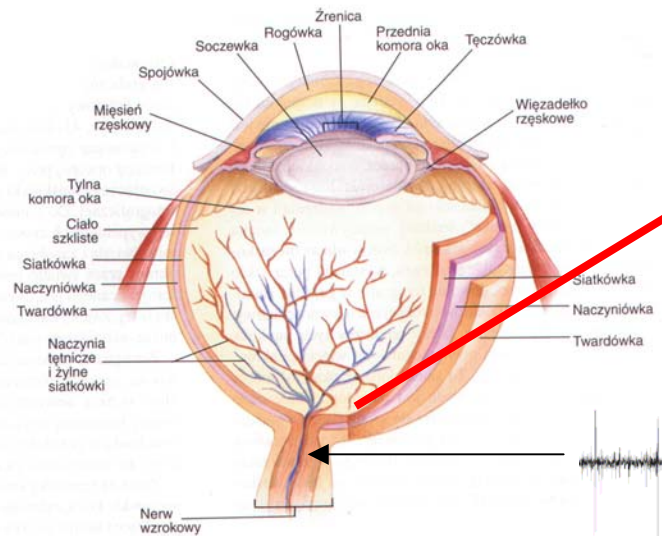
Neural systems

BRAIN

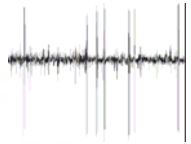


Bibliographic Entry	Result (w/surrounding text)	Standardized Result
<i>Glencoe Health 2nd Edition</i> . Mission Hills: Glencoe Inc., 1989: 252.	"Weighing around three pounds (1.35kg), the brain contains nearly 100 billion cells."	100 billion
<i>World Book 2001</i> . Chicago: World Book Inc., 2001: 551.	"The human brain has from 10 billion to 100 billion neurons."	10 - 100 billion
<i>Magill's Medical Guide Revised Edition</i> . Salem Press, 1998: 221.	"It has been estimated that the adult brain has around one hundred billion neurons and an even larger number of glial cells."	100 billion
<i>The Science Times Book of the brain</i> . New York: The Lyons Press, 1987: 150.	"The human brain holds about 100 billion nerve cells."	100 billion
<i>The Scientific American Book of the Brain</i> . New York: Scientific American, 1999: 3.	"An adult human brain has more than 100 billion neurons"	> 100 billion

RETINA



Cones: 6.5×10^6 (colours)
Rods: 125×10^6 (move, shape)
Optical nerve: 1×10^6 fibers



AIM: to build an electronic interface

for recording/stimulation of neuronal system comprising several hundreds or thousands of electrodes



Motivation

1. Understand neuronal coding,
2. Biosensors
3. Neuronal prostheses



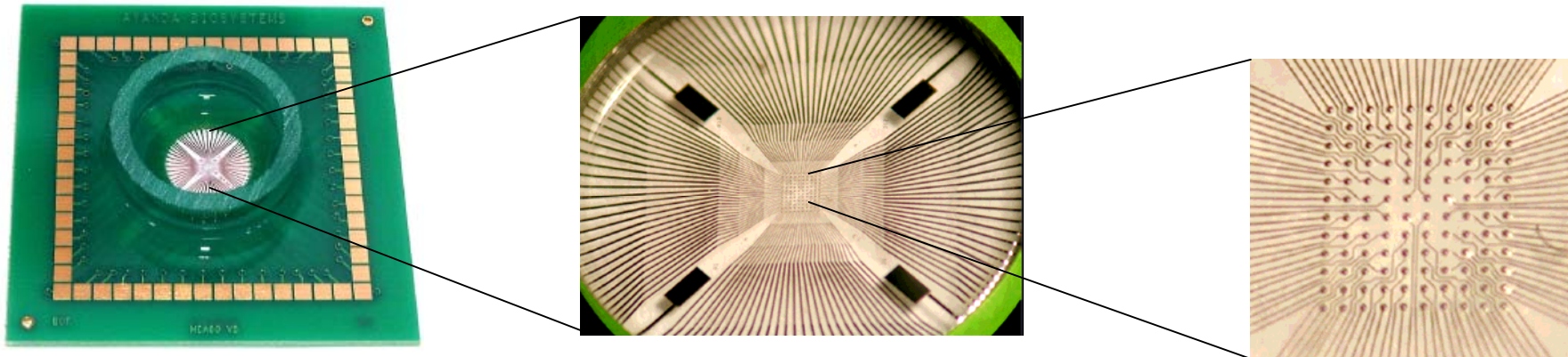
Components

1. Microelectrode array
2. Multichannel electronics

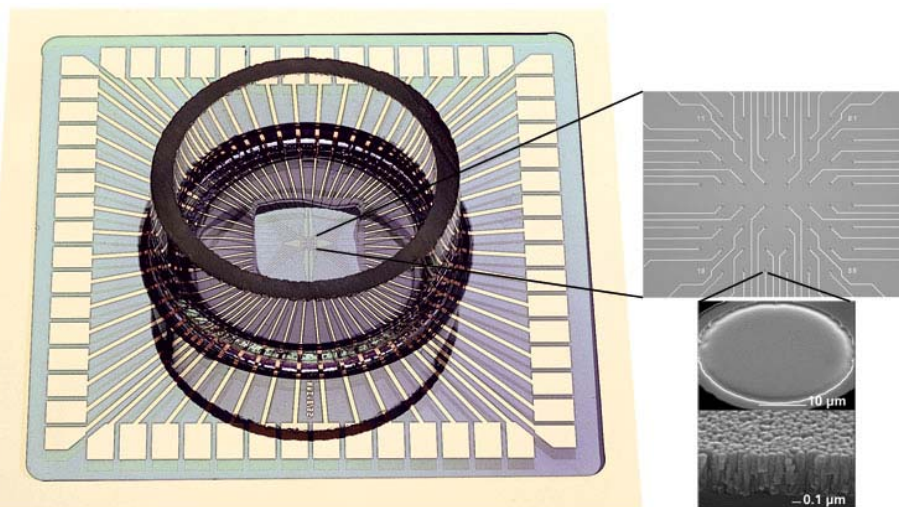


Microelectrode arrays I – planar microelectrodes

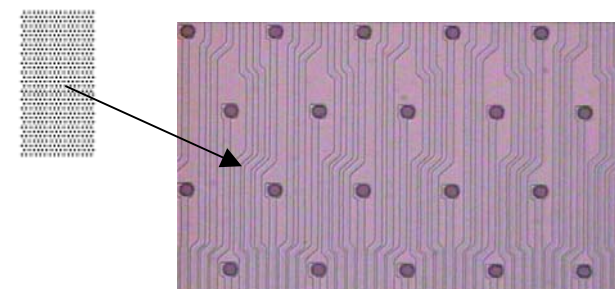
Ayanda Biosystems



Multi Channel Systems



University of Glasgow

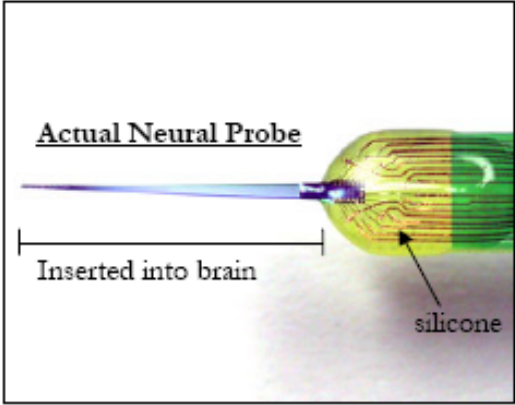
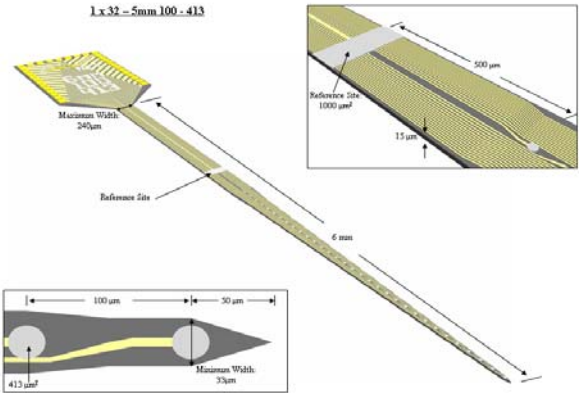
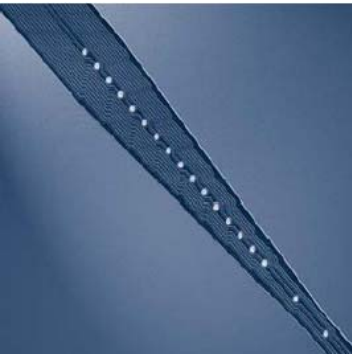


512-electrode array 32x16:
spacing = 60 um diameter = 5 um

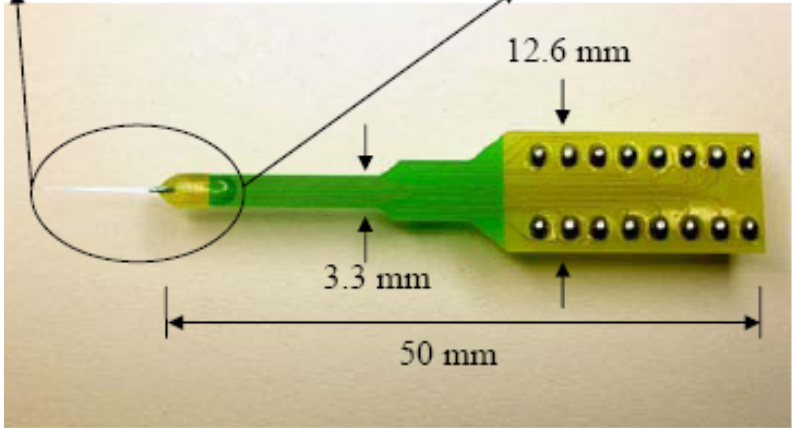
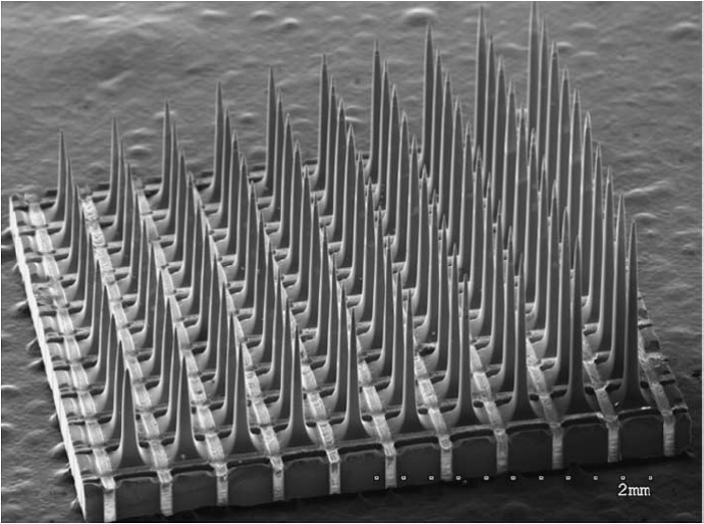


Microelectrode arrays II - Microprobes

NeuroNexus Technologies



Utah Microelectrode Array



Recording/stimulation electronics – standart solutions



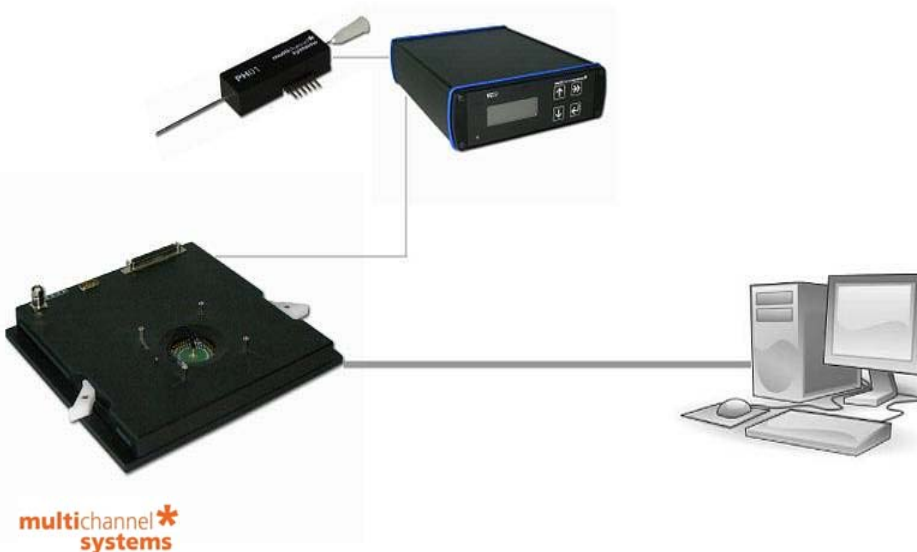
4-channel recording amplifier



8-channel stimulus generator



60-channel recording system

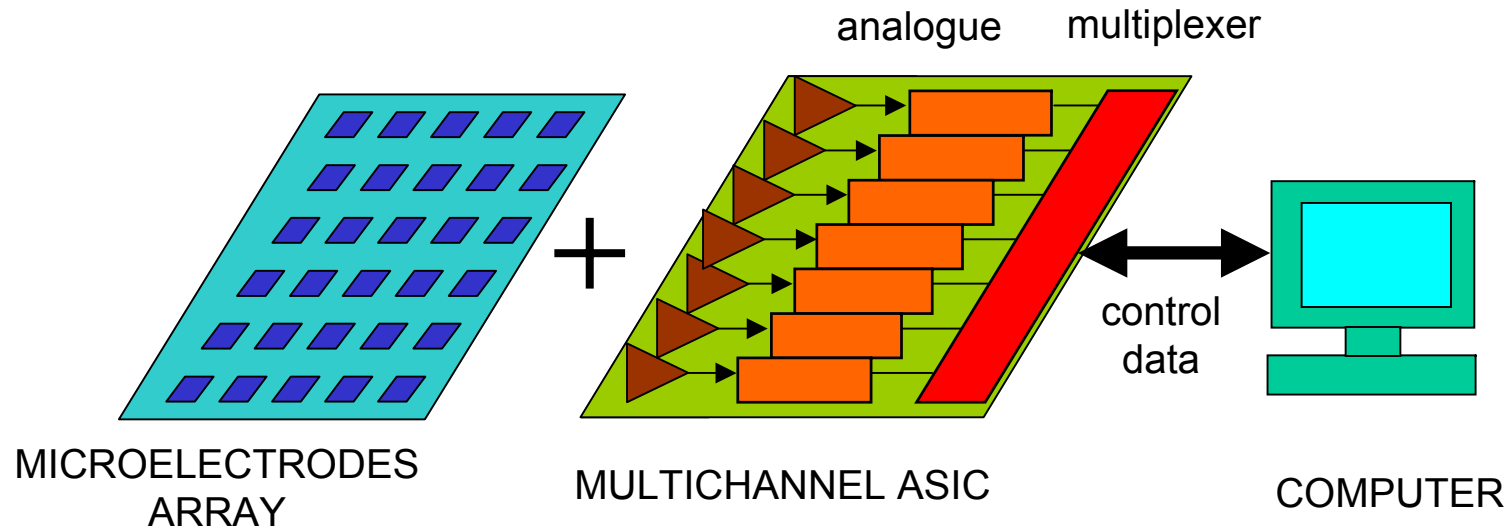


Limits:

- number of channels
- large volume and weight
- high costs



Multichannel neuribiological recording based on ASIC



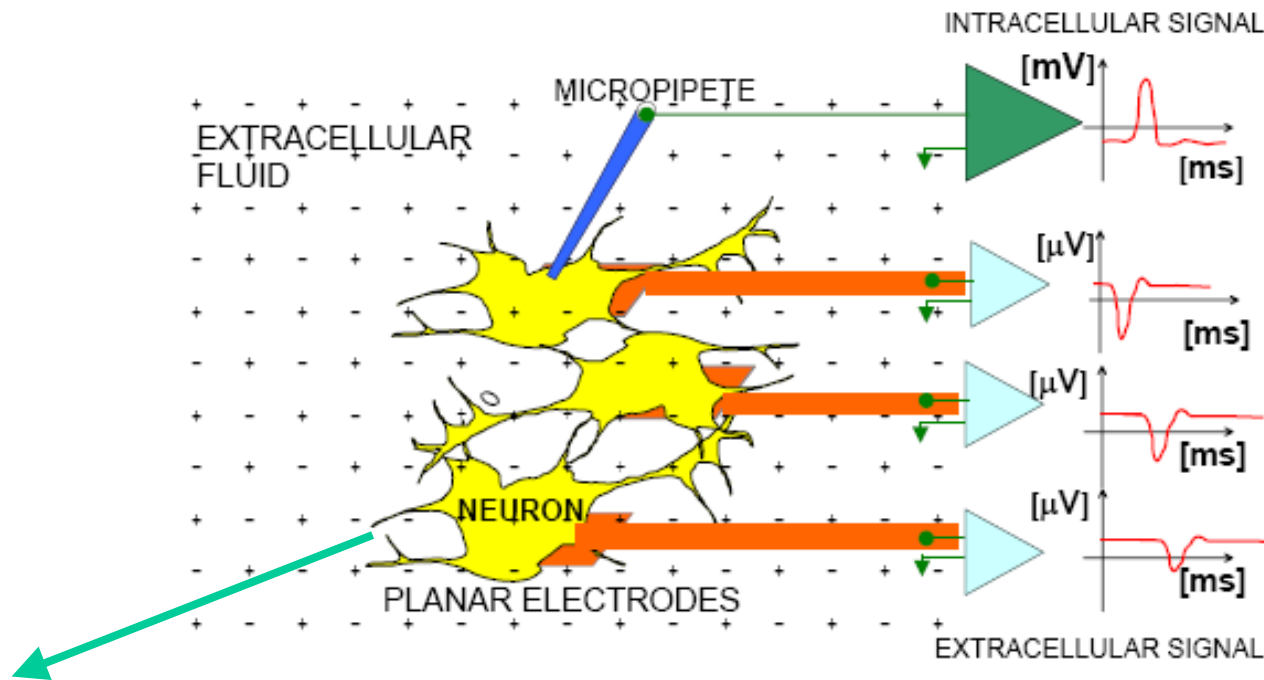
To design a multichannel
APPLICATION SPECIFIC INTEGRATED CIRCUIT (ASIC),
which is able to cope with extracellular neuronal recording

↓ system

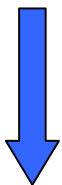
- to built recording system comprising several hundreds or thousands of electrodes
- miniaturization



Extracellular recording – requirements for electronics



Signal source (e.g. retina tissue): $V_{amp} = 50-500 \mu\text{V}$, DC offsets,
 $t_w \approx 1-2 \text{ ms}$, band: 20 -2000 Hz,



Requirements:

- Low noise $\sim 5 \mu\text{V rms}$
- Frequency band pass 20 Hz to 2000 Hz
- AC coupled input cut-off frequency $< 20 \text{ Hz}$

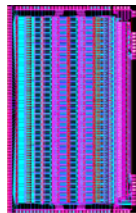
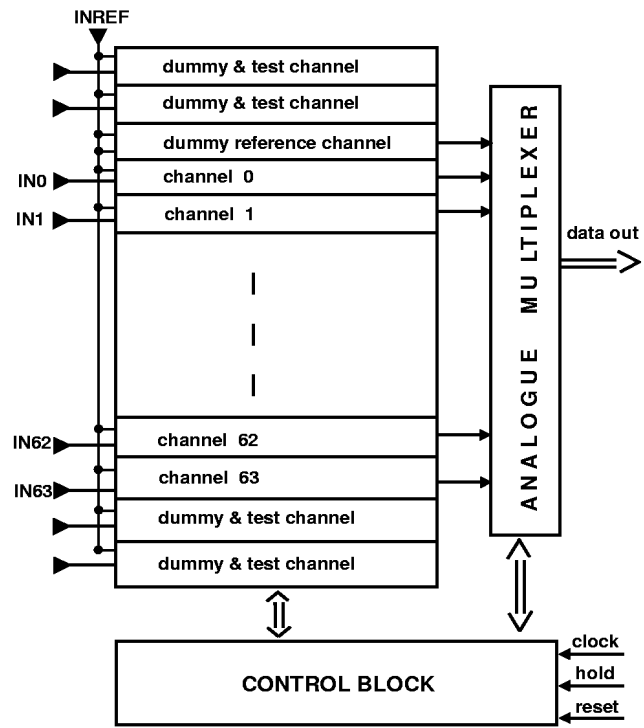


**MULTICHANNEL
ARCHITECTURE**



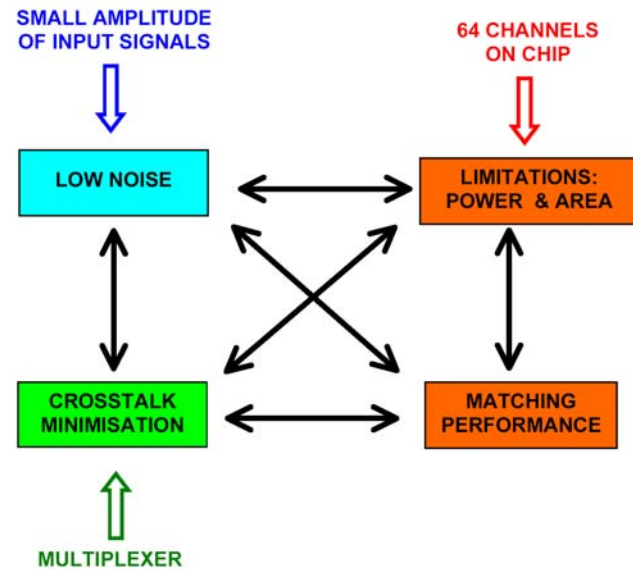
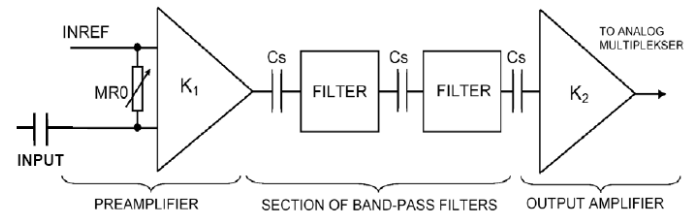
Multichannel architecture

64 channel ASIC - NEURO64



CMOS technology 0.7 μm
4 mm x 6 mm

Single channel architecture



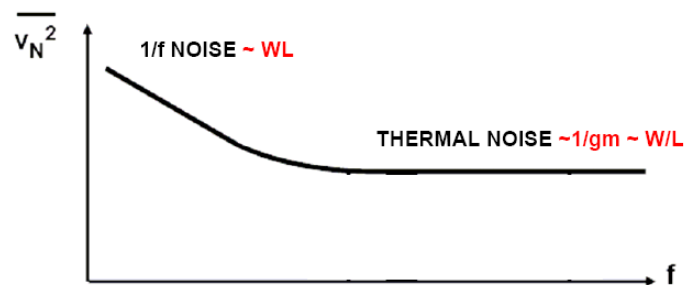
LIMITATION OF CMOS TECHNOLOGY



CMOS technology - noise

MOS transistors:

- flicker noise \Leftarrow low frequency,
- thermal noise \Leftarrow power limitation



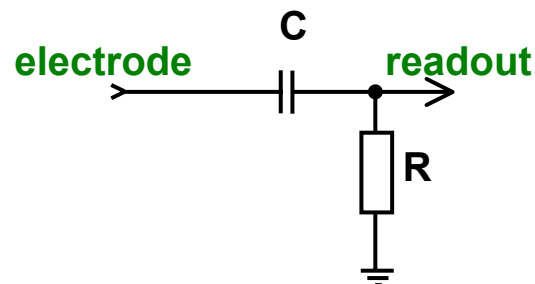
AC-coupling -kT/C noise:

- small capacitors \Leftarrow area limitation

CMOS technology: $C = 1\text{pF} \Rightarrow 64\mu\text{V rms}$

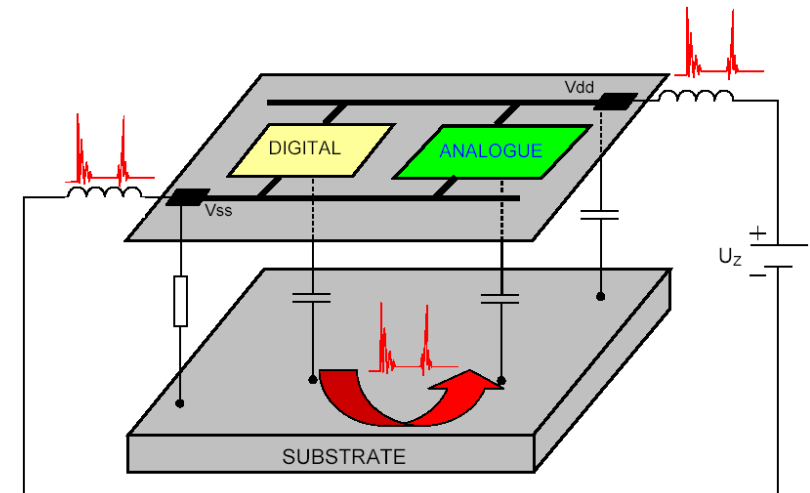
$C = 100\text{pF} \Rightarrow 6.4\mu\text{V rms}$

SMD technology: $C = 10\text{nF} \Rightarrow 0.64\mu\text{V rms}$

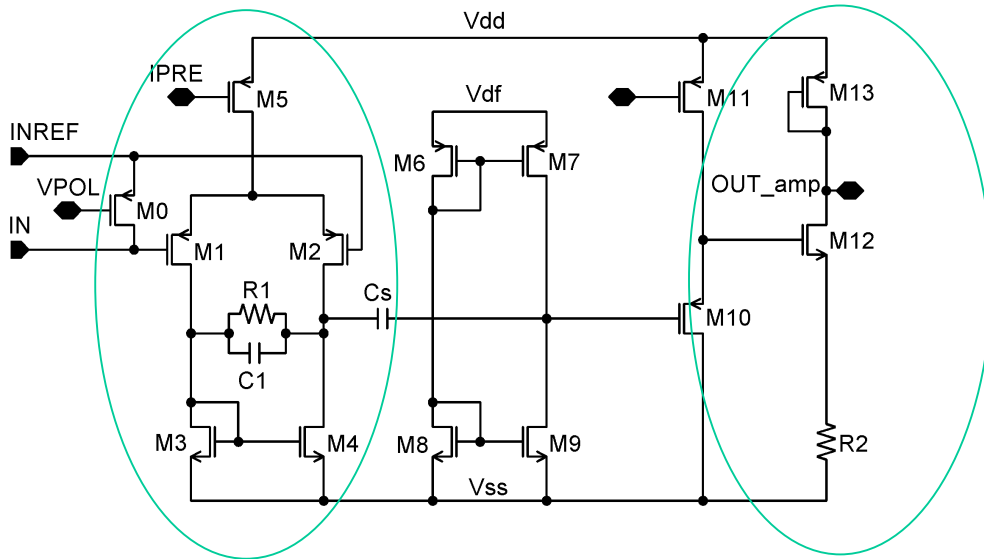


Crosstalk:

- supply bounce,
- substrate noise



Low noise preamplifier



Flicker noise

$$\frac{dv_{1/f_dif}^2}{df} = \frac{2K_{fp}}{C_{ox}W_1L_1} \left(1 + \frac{\mu_n K_{fn} L_1^2}{\mu_p K_{fp} L_3^2} \right) \frac{1}{f}$$

MINIMUM: $\Rightarrow \frac{L_1}{L_3} = \sqrt{\frac{K_{fp}\mu_p}{K_{fn}\mu_n}}$

+ Thermal noise



HSPICE



PRODUCTION MEASUREMENT

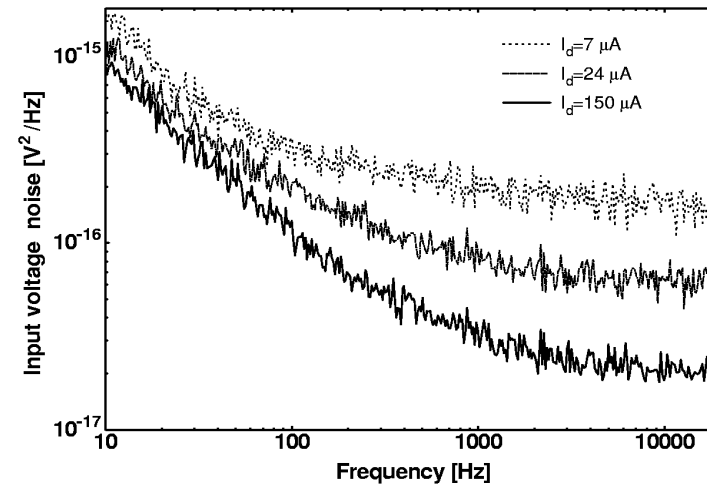


M1: 1500/2
M3: 100/24

.....

Technology (Alcatel-Mietec CMOS 0.7μm): $KF_{NMOS} = 3e-28 \text{ V}^2\text{F}$, $KF_{PMOS} = 5e-30 \text{ V}^2\text{F}$

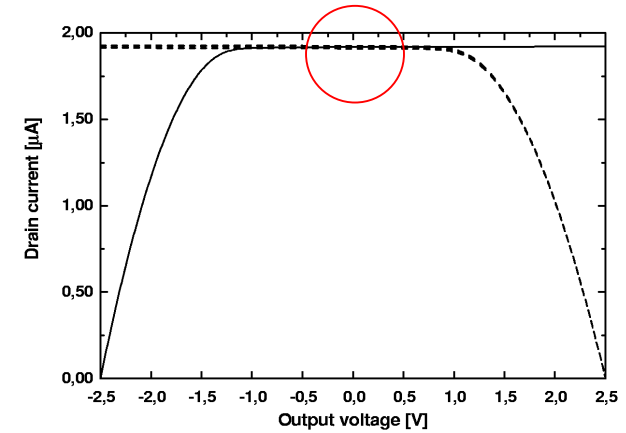
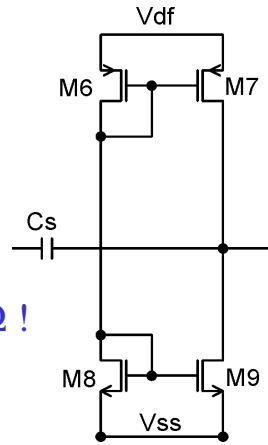
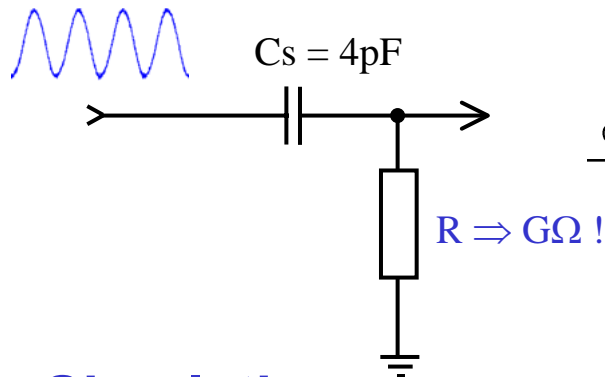
BANDPASS FILTER



Power: < 2 mW/channel
Noise: 2 μV rms (10Hz-20kHz)

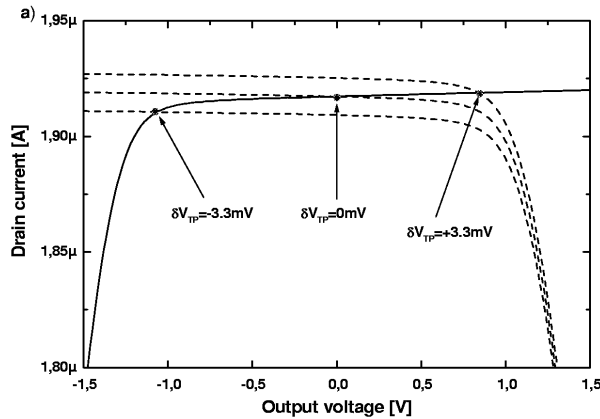


AC coupling – NEURO64

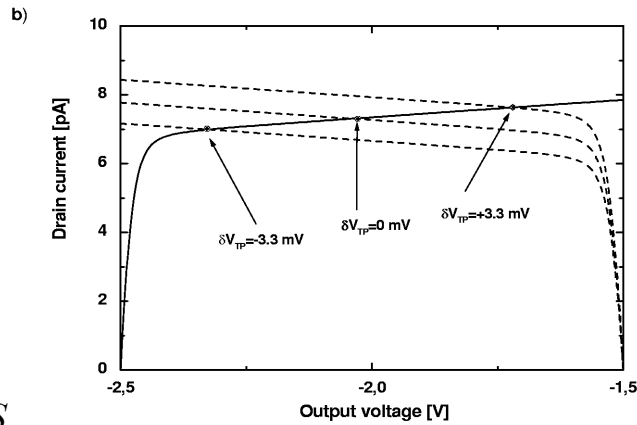


Simulations

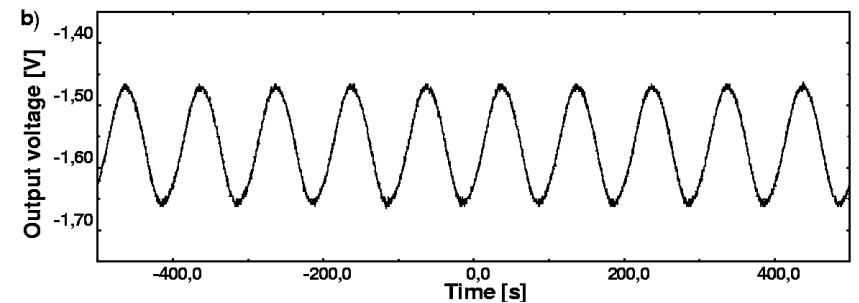
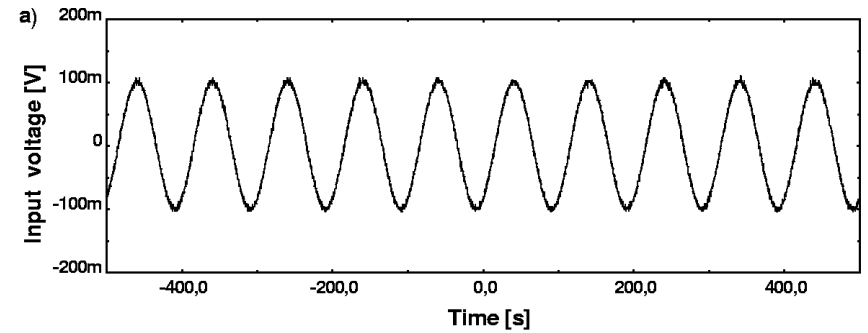
WEAK INVERSION



STRONG INVERSION



Measurements f=10 mHz



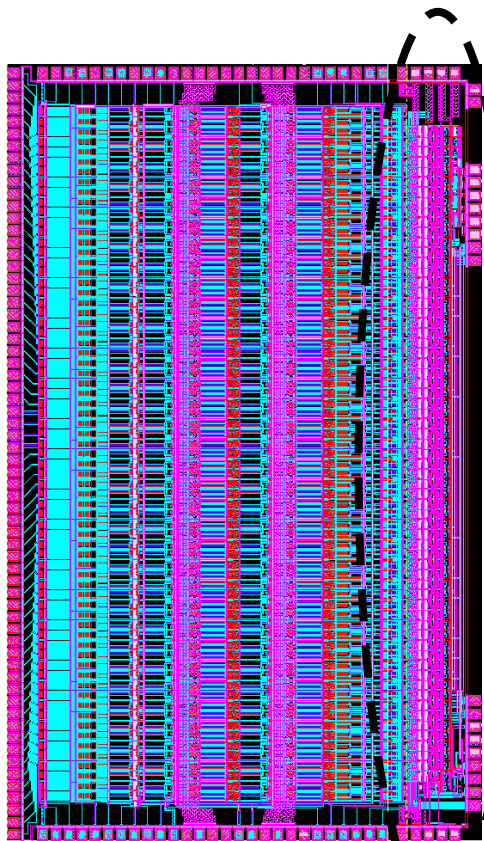
SP↓NS

ansfer”, Kraków 2008

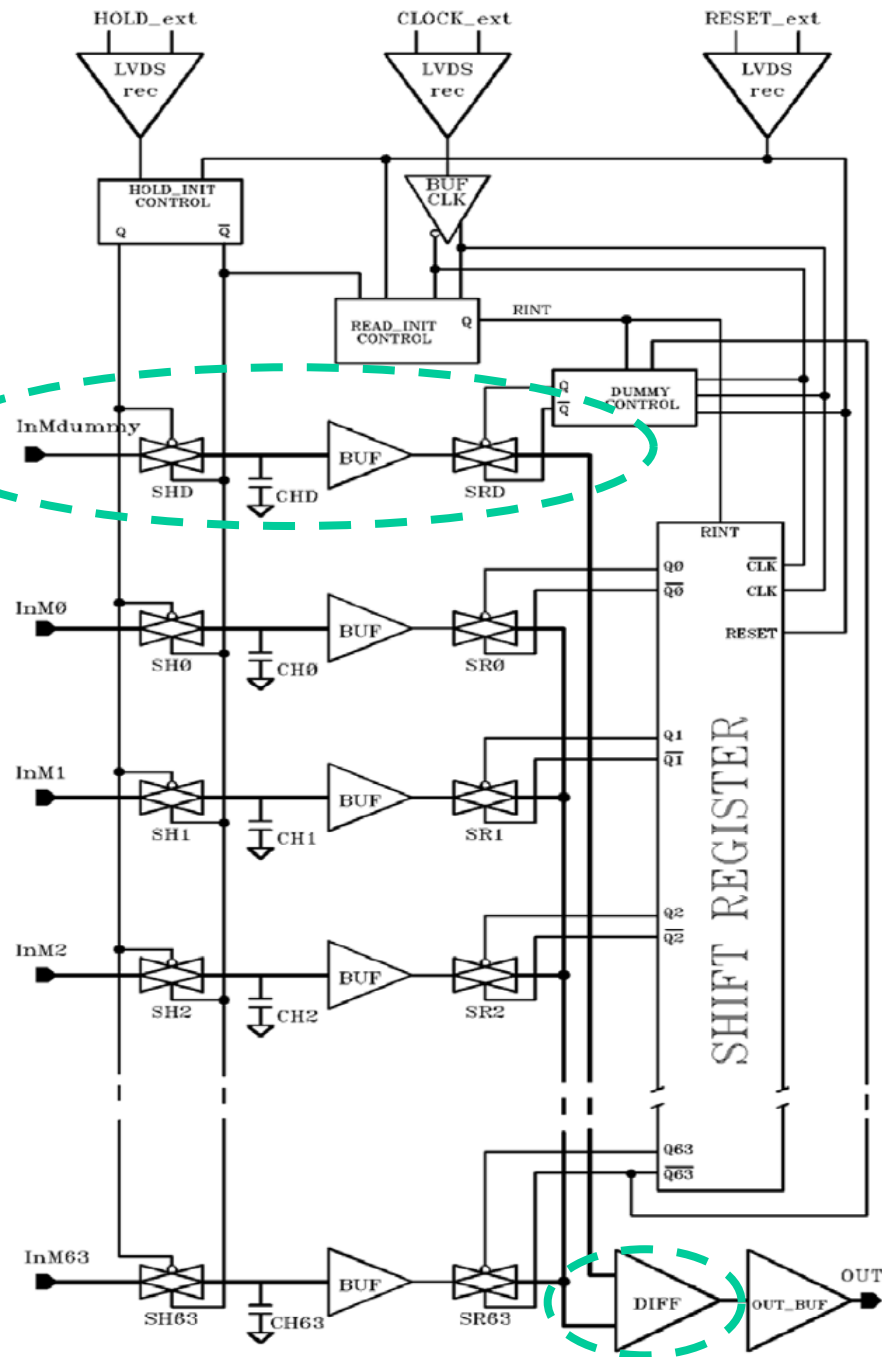
Katedra Metrologii

Akademia Górniczo-Hutnicza w Krakowie

**CROSSTALK PROBLEM:
analogue multiplexer
(input noise $V_{IN-rms} < 5 \mu V_{rms}$)**



Reference channel



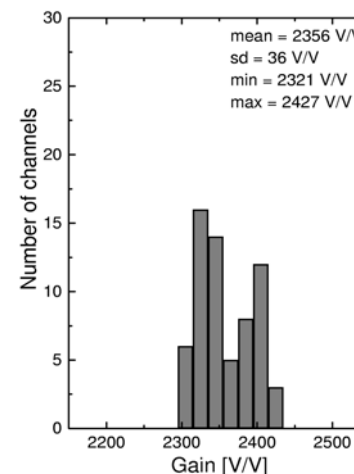
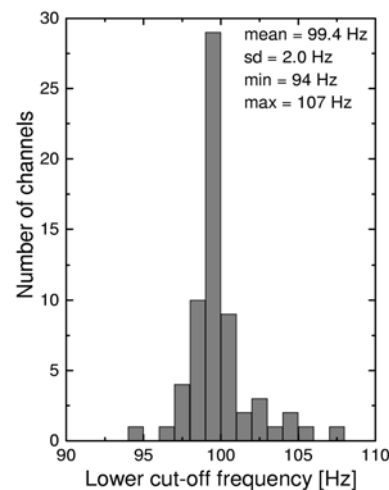
Multiplexer in NEURO64 \Rightarrow to reduce crosstalk



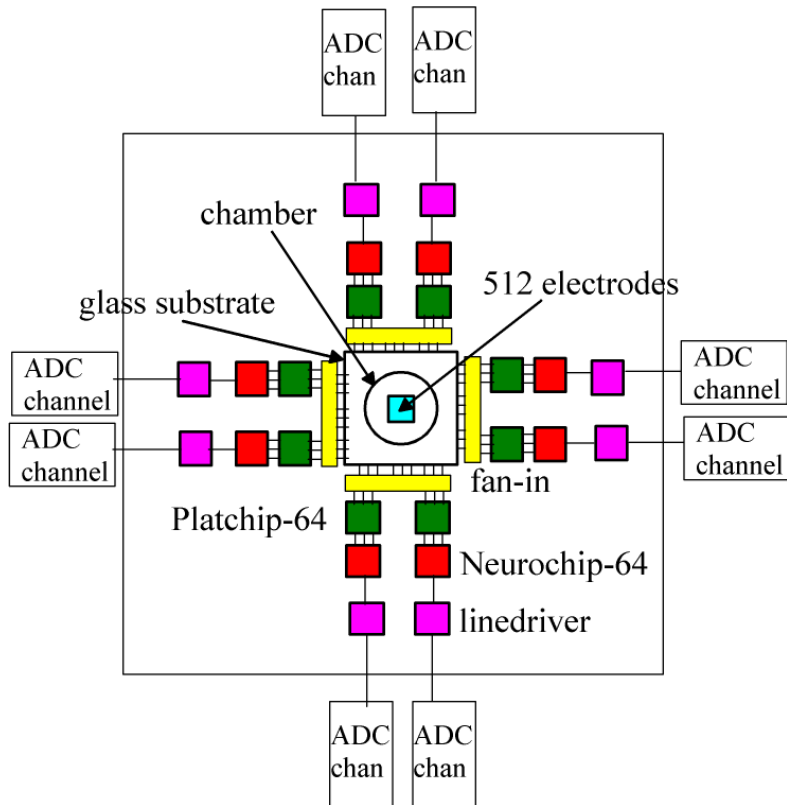
Measure parameters

Parameter	Measured value
Bandwidth	30 to 1400 Hz
Total equivalent input noise	3 μV rms
Input signal linear range	960 μV_{pp}
Tolerance to the input offset	-8 mV, +11 mV
Gain	1000 V/V
Spread of the gain channel to channel (std)	< 1.3%
Input signal common mode range	+/-300 mV
Power dissipation per channel	1.7 mW
Power supplies	-2.5 V, +2.5 V
Single channel area	100 $\mu\text{m} \times 3500 \mu\text{m}$

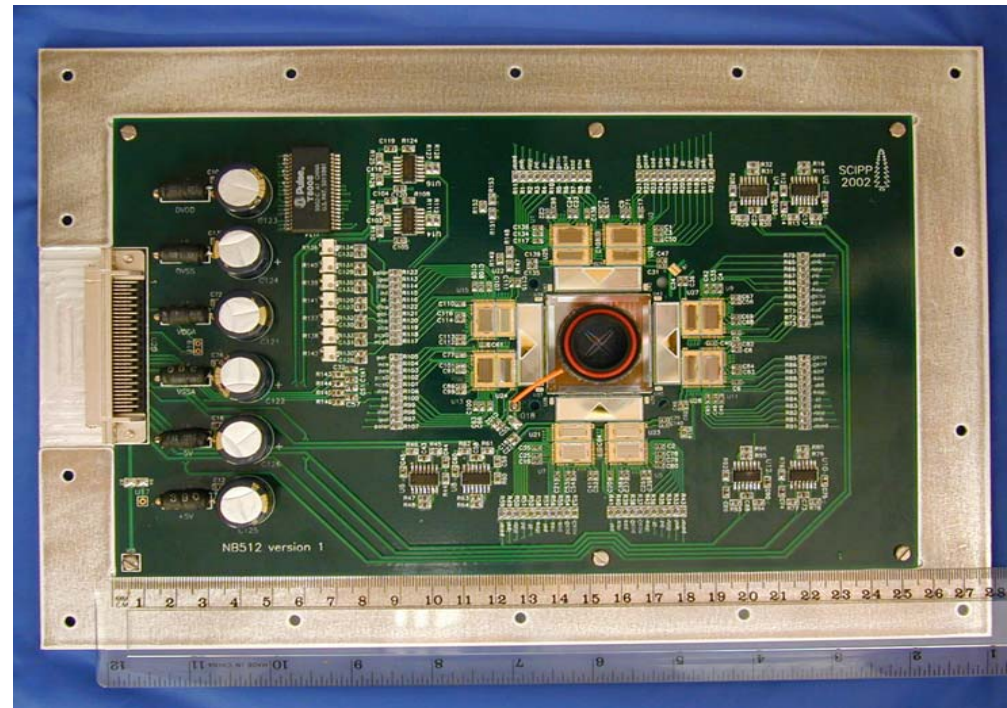
Matching



Example of practical application: RETINAL READOUT SYSTEM



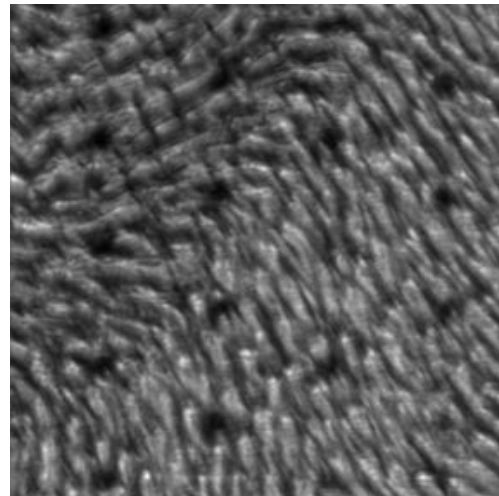
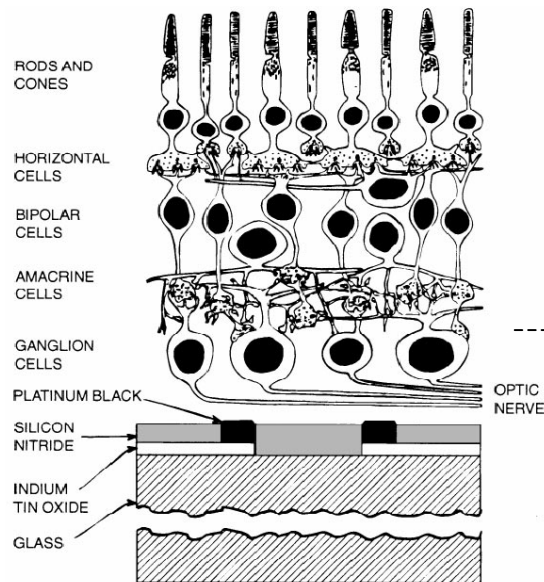
Four group of people from:
 UC - Santa Cruz: **data acquisition system & analysis**
 AGH UST - Krakow: **IC design and testing**
 Univ. Glasgow – UK: **microelectrode fabrication**
 Salk Institute - San Diego: **neurobiology**



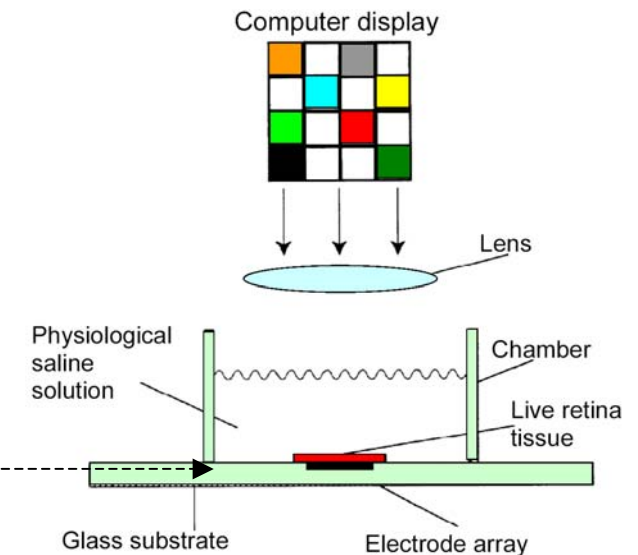
Experimental set-up

RETINAL READOUT SYSTEM

Experiments have been done in:
 Salk Institute, San Diego
<http://www.snl-e.salk.edu>



Retinal tissue placed on top of multielectrode array



**A movie is focused
 on the retina tissue**

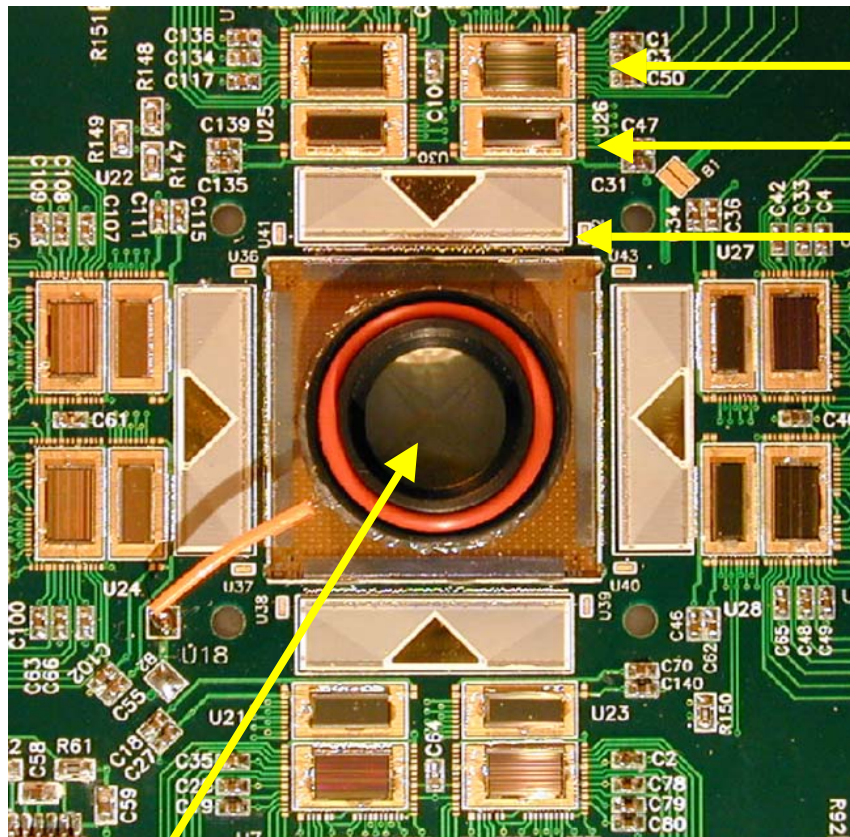


**The patterns of electrical activity
 generated by hundreds of retinal
 output neurons are recorded**



Working system with 512 readout channels

To understand how the retina processes and encodes dynamic visual image

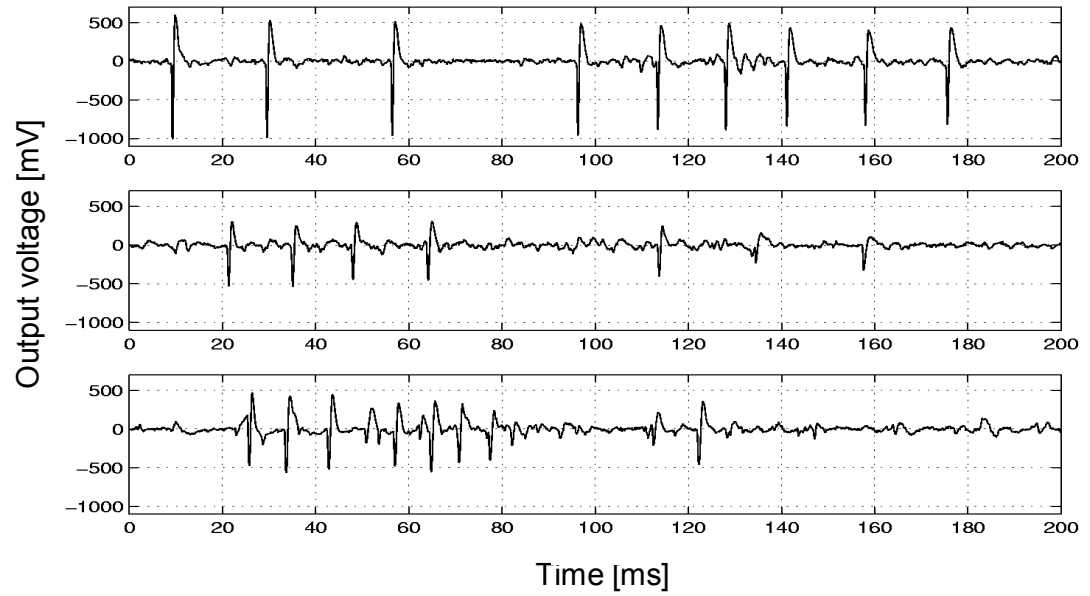


512 electrodes
with retina tissue

NEURO64

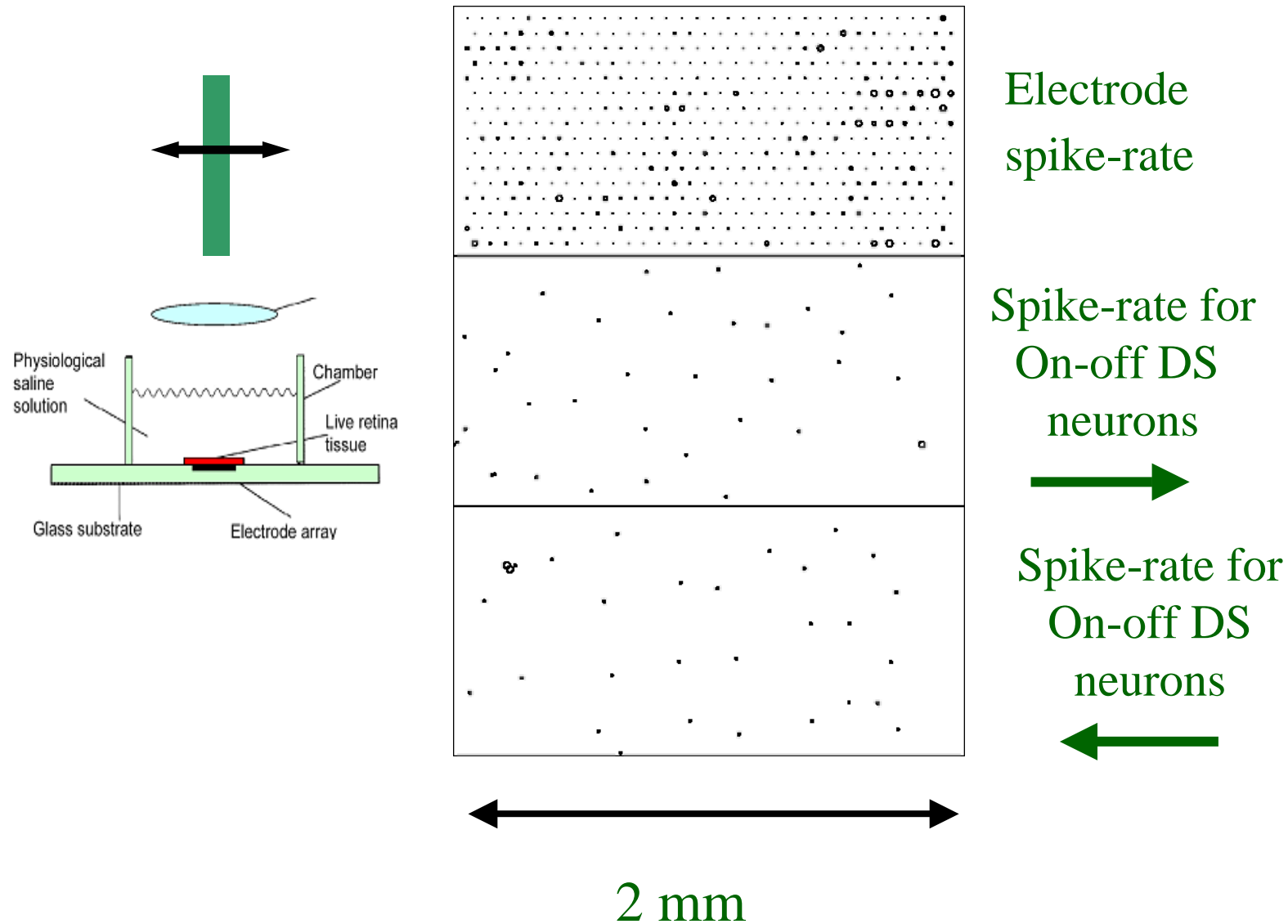
PLAT64

"pitch
adaptor"



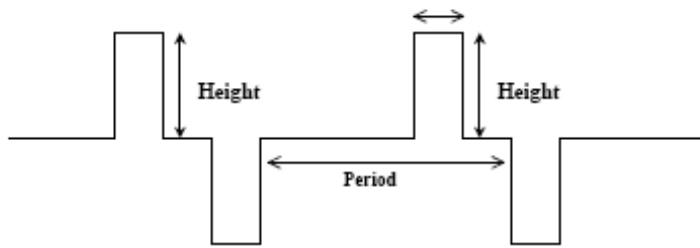
Tests with the monkey retina – moving bar

(Litke, et. al.)



Additional functionally required: RECORDING + STIMULATION+TELEMETRY

Stimulation Pulse Parameters

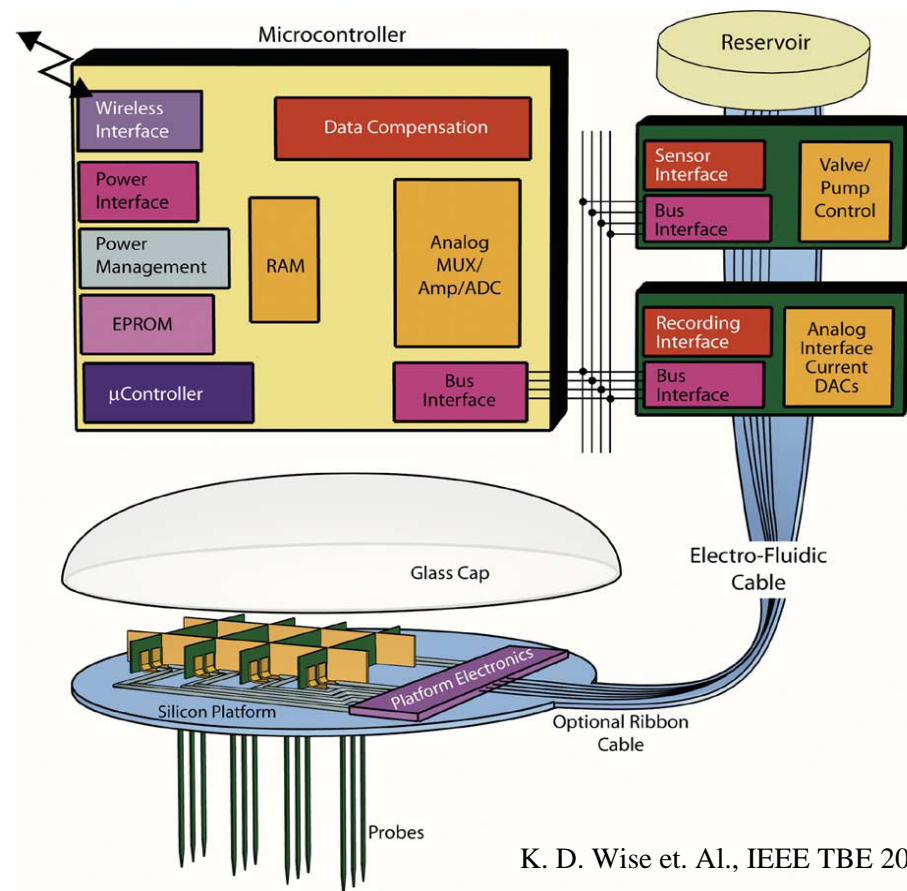


Width - [0.1ms-2ms]

Period - [10Hz-125Hz]

Height - [100μA-600μA]

IDEAL SYSTEM



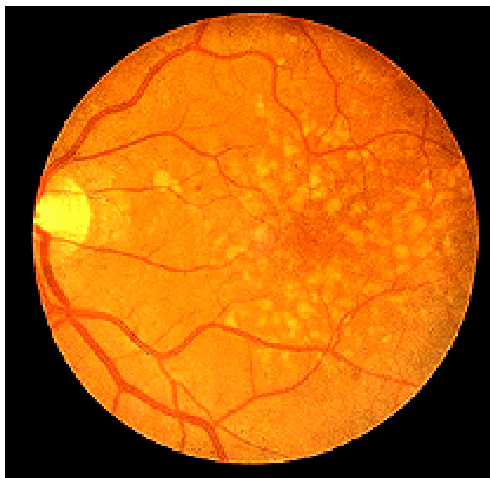
K. D. Wise et. Al., IEEE TBE 2004



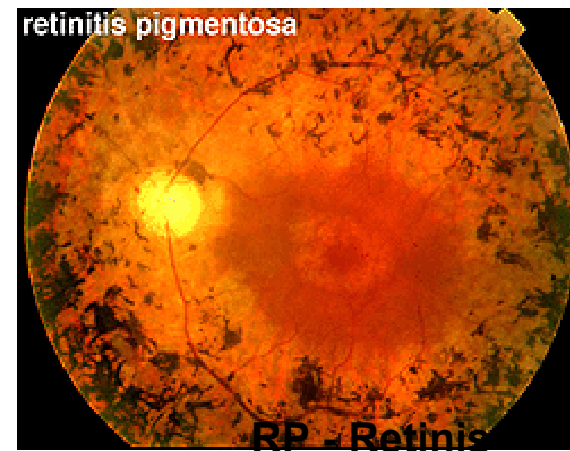
Effect of Retina Diseases.



Normal



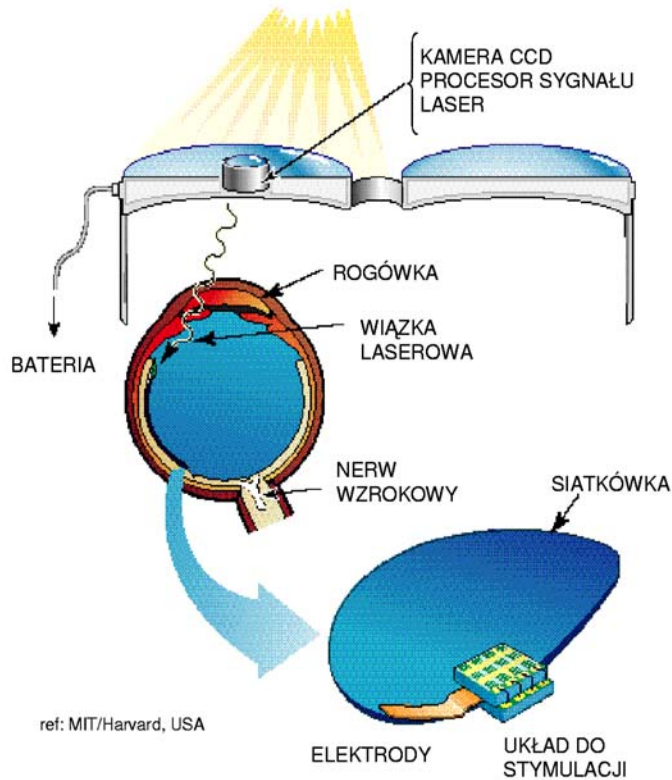
Macular Degeneration (AMD)



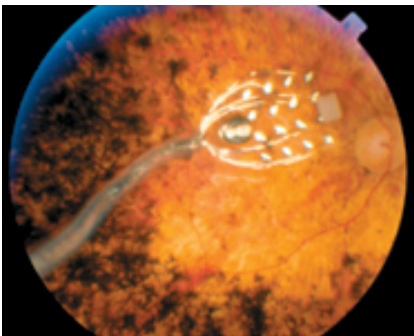
Pigmentosa
(12 mln people)



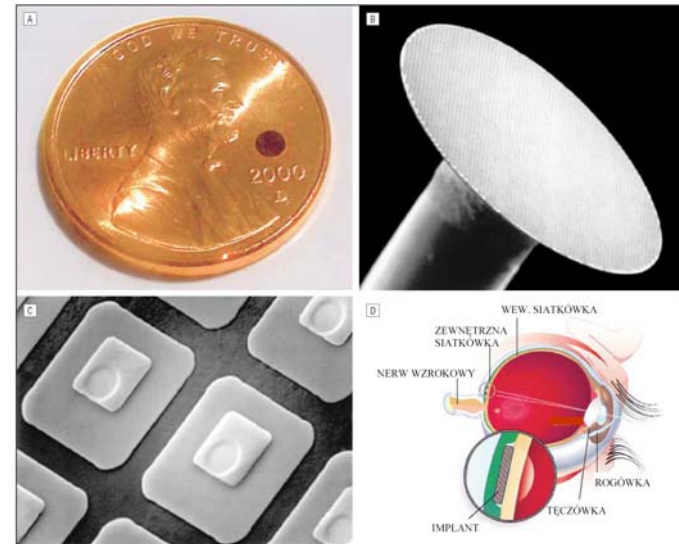
System MIT/Harvard (epiretinal implant)



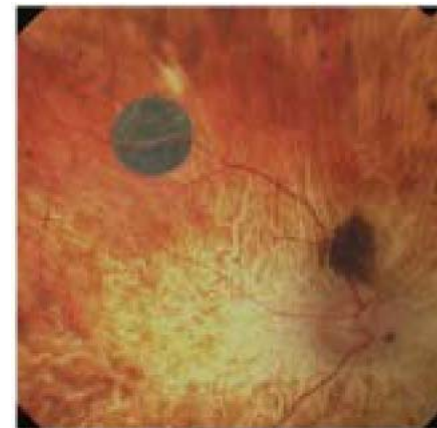
ref: MIT/Harvard, USA



Optiobionics Corporation (subretinal implant)



ASR: 2 mm x 25 μ m
5000 pixels, : 20 μ m x 20 μ m



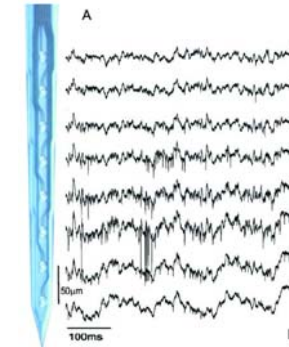
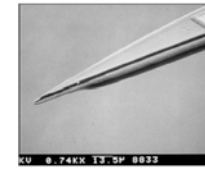
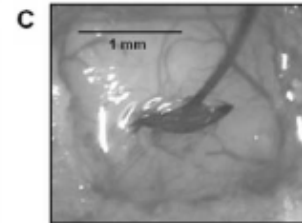
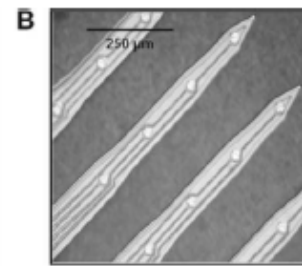
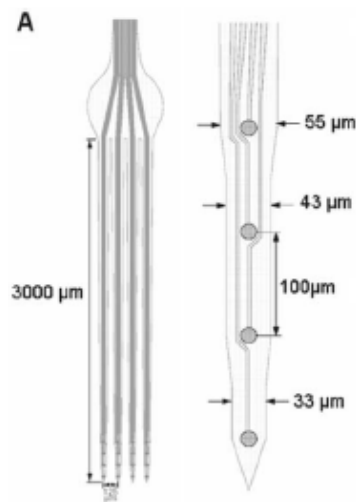
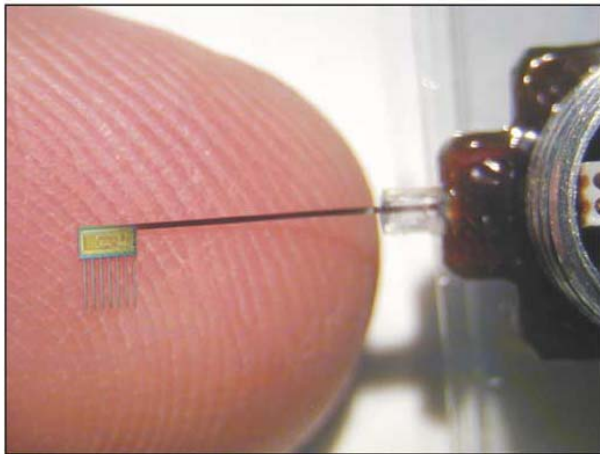
Near Visual Acuity Test
MODIFIED ETORS WITH SLOAN LETTERS
For testing at 40 cm (16 inches)

Letter Size (metric)	Chart 1				
	Snellen Distance Equivalent		Dopters of Add for 1 M		
	at 40 cm	at 20 cm	at 20 cm	at 20 cm	
8.0 MM	N C K Z O	20/400	2/0	20/900	4/0
6.4 MM	R H S D K	20/300	1/50	20/600	3/0
5.0 MM	D O V H R	20/250	1/20	20/500	2/50
4.0 MM	C Z R H S	20/200	1/10	20/400	2/0
3.2 MM	O N H R C	20/150	8/0	20/300	1/50
2.5 MM	D K S N V	20/125	6/0	20/250	1/20
2.0 MM	Z S O K N	20/100	5/0	20/200	1/0
1.6 MM	C K D N R	20/80	4/0	20/150	8/0
1.25 MM	S R Z K D	20/60	3/0	20/125	6/0
1.0 MM	H Z O V C	20/50	2/50	20/100	5/0
.8 MM	K S D K	20/40		20/80	4/0
.6 MM	V S E D	20/30		20/60	3/0
.5 MM	H S E D	20/25		20/50	2/50
.4 MM	V S E D	20/20		20/40	
.3 MM	V S E D	20/15		20/30	

Instructions: the 40cm test distance requires a maximum add of +2.50. If the patient cannot see the top line, move test distance to 20cm with a maximum add of +5.00. (Similarly if a 10cm test distance is required, the maximum add is +10.00)
Record test distance and letter size from the left column. Examples: 40/4M, 20/4M
The columns on the right provide reference to Snellen distance equivalent for two test distances; diopters of add for 1M print size for two test distances.

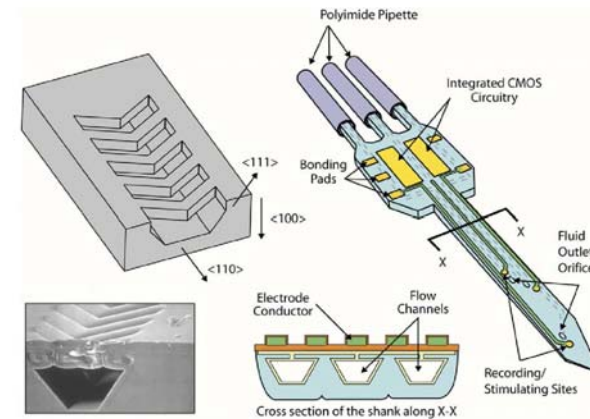


Deep brain stimulation – microprobes



NeuroNexus Technologies

Next step - MEMS



J Neurophysiol 90: 1314–1323, 2003;
10.1152/jn.00116.2003.

Katedra Metrologii

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Summary

